

**TMS 2006 ELECTRONIC
MATERIALS
CONFERENCE**
and Exhibition

June 28-30, 2006
Pennsylvania State University
University Park, PA

ADVANCE PROGRAM

TMS

Sponsored by the
Electronic, Magnetic & Photonic
Materials Division

www.tms.org/EMC.html

*The Premier Annual Forum on the
Preparation and Characterization of
Electronic Materials*

**TMS 2006 ELECTRONIC
MATERIALS
CONFERENCE**

**June 28-30, 2006
Pennsylvania State University
University Park, PA**

Who Attends?

More than 500 individuals actively engaged or interested in electronic materials research and development, both within and outside the United States, including:

- Scientists
- Engineers
- Researchers
- Technicians
- R&D Managers
- Product Managers
- Professors
- Students

Ensure you are among the professionals who gain valuable knowledge to advance their work in electronic materials by registering today!

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Programming

Late News Papers

Late news papers will be considered. Authors must submit a 450-word abstract at <http://cmsplus.org> by June 3. An optional one-page “extended abstract” can be submitted as well to assist organizers in considering the late news paper. Instructions for electronic submission are online at cmsplus.org.

Technical Sessions

Technical sessions will be held at the Penn Stater Conference Center; the conference plenary session will be located in Presidents Hall 3 & 4.

See page 21 for session and paper titles.

Program

Registrants will receive a complete program with abstracts of papers to be presented at the meeting, at the on-site registration desk.

Audio/Video Recording Policy

TMS reserves the right to all audio and video reproductions of presentations at TMS sponsored meetings. Recording of sessions (audio, video, still photography, etc.) intended for personal use, distribution, publication, or copyright without the express written consent of TMS and the individual authors is strictly prohibited.

About TMS

The Minerals, Metals & Materials Society (TMS) is the professional organization encompassing the entire range of materials in science and engineering, from minerals processing and primary metals production to basic research and the advanced applications of materials.

Included among its professional and student members are metallurgical and materials engineers, scientists, researchers, educators and administrators from more than 70 countries on six continents.

TMS' mission is to promote the global science and engineering professions concerned with minerals, metals and materials.

To learn more, visit **www.tms.org**

Networking & Social Events

Welcoming Reception for Attendees

Wednesday, June 28, 6 to 8 p.m.

Penn Stater Conference Center, Presidents Hall 1 & 2

Evening at Beaver Stadium for Attendees and Guests

Thursday, June 29, 6 to 9 p.m.

Beaver Stadium

Enjoy a catered dinner and complimentary access to the sports museum located within Beaver Stadium.

Cost: Free to full conference and student registrants

\$65 for one-day registrants and adult guests

\$30 for children age 12 and under

Tickets: Advance purchase is recommended; order on the enclosed registration form. A limited number of tickets will be available for purchase at the EMC registration desk. Deadline for ticket sales is 5 p.m. on Wednesday, June 28.

Informal Coffee Breaks for Attendees

Intermission of morning and afternoon sessions

Presidents Hall 1 & 2, first and second level break areas

Light Fare and Beverages Served

Registration

Register before June 12 to save time and money!

Visit www.tms.org/EMC.html or complete the form on page 65.

Advance Registration Fees

Full Conference	\$400
One Day	\$360
Student	\$185

Your registration fee includes:

Technical Sessions
Exhibition
Welcoming Reception
Coffee Breaks
Thursday Banquet*

**(One Day registration does not include Thursday banquet.)*

Value for Your Cost

The Electronic Materials Conference (EMC) will be held at the Penn Stater Conference Center, June 28-30, and is being coordinated with the Device Research Conference held at the same location, June 26-28. Badges will be accepted by both conferences on Wednesday, June 28.

On-Site Registration*/Advance Registrant Badge Pick-Up

Penn Stater Conference Center, First Level

Tuesday, June 27	3 to 5 p.m.
Wednesday, June 28.....	7:30 a.m. to 5 p.m.
Thursday, June 29	7:30 a.m. to 4 p.m.
Friday, June 30.....	7:30 to 10 a.m.

**On-site registration fees are higher than advance registration fees.*

Refund Policy

A request for a refund due to a cancellation must be made in writing and postmarked no later than June 12, 2006. Mail to: TMS, 184 Thorn Hill Road, Warrendale, PA 15086-7514 USA. A \$75 processing fee is charged for all cancellations. No refunds are issued after the deadline.

Awards

John Bardeen Award

Established in 1994, this award recognizes an individual who has made outstanding contributions, and is a leader, in the electronic materials field.

2006 Recipient: Isamu Akasaki

Citation: For his pioneering work and key discoveries in the field of GaN and related materials which has enabled their widespread development and use



About the Recipient: Isamu Akasaki is a professor at Meijo and Nagoya universities in Japan, where his research over the past 25 years has surrounded compound semiconductor materials and devices, with special emphasis on nitride semiconductors. He has published more than 580 scientific papers, edited nine books and received a total of 133 patents, including 65 for Group III Nitrides. Dr. Akasaki has also received numerous awards including selection by the Japanese government as a "Person of Cultural Merits" in 2004.

"Dr. John Bardeen is a great scientist with outstanding achievements in two fields of electronic materials in the last century, whom I highly respect. I deem it indeed a great honor to be selected as a recipient of the TMS John Bardeen Award. Moreover, all of the past recipients of this prestigious award have made significant achievements and are excellent leaders in the field of electronic materials; they have helped promote the importance of this award. It is a real honor for me to be among these distinguished scientists."

Nominate a Deserving Colleague for the TMS 2008 John Bardeen Award!

This award recognizes an individual who has made an outstanding contribution, and is a leader, in the field of electronic materials.

Who was John Bardeen?

John Bardeen's career of theoretical and experimental research set the foundation for the current state of understanding of electronic materials. Two areas where Bardeen had great impact were the invention and development of the solid-state transistor and the theory that developed greater understanding of superconductivity.

For Award Criteria and Additional Information

Pick up a nomination form at the EMC registration desk, or visit the TMS Web site at www.tms.org/Society/honors.html.

Especially for Students

Student Paper Awards

Awards of \$500 are given to the authors of the top five percent of student papers presented at the 2005 EMC. Student papers are judged on both scientific content and oral presentation. Awards are funded by the Electronic Materials Committee and presented during the plenary session on Wednesday, June 28.

Student Travel Awards

Student authors who are presenting papers may be eligible for travel assistance. To apply, submit a letter no later than June 1, 2006 to:

Edward Yu, General Chair

University of California

ECE Dept. MC 0407

9500 Gilman Drive

La Jolla, CA 92093

Telephone: (858) 534-6619

Fax: (858) 822-3425

E-mail: ety@ece.ucsd.edu

Student travel assistance is made possible through generous donations from the EMC Foundation.

Attention Students!

Become a member of the Material Advantage student program for only \$25 and reap the benefits of four varied materials organizations!

ACerS = The American Ceramic Society

AIST = Association for Iron & Steel Technology

ASM = ASM International

TMS = The Minerals, Metals & Materials Society

For full details on benefits, which include scholarships and awards totaling more than \$600,000, visit www.materialadvantage.org.

Material Advantage

Everything Else Is Immaterial!

Exhibition

Attention Suppliers of Technology for Preparation and Characterization of Electronic Materials –

Be a part of the unique showcase at the EMC Technological Exhibit!

Reach more than 500 professionals from industry, government laboratories and academia looking for these products and services:

- Advanced thin-film characterization
- Chemical Vapor Deposition (CVD)
- Compound semiconductor materials
- Failure analysis
- GaAs and InP-based epitaxial wafers, substrates
- High performance purification
- High purity metalorganics
- III-V materials
- Materials characterization
- MOCVD
- Optoelectronics
- Sapphire substrates
- Scanning probe and electron microscopes
- Silicon heterostructures
- Ultra High Purity (UHP) metals, gas and chemical
- Wafer processing equipment
- Wide bandgap semiconductors

Exhibit Dates and Hours

Presidents Hall 1 & 2

Wednesday, June 28..... 9:20 a.m. to 4 p.m.
6 to 8 p.m.

Thursday, June 29 10 a.m. to 4 p.m.

Your Guarantees as an Exhibitor

- Complimentary listing in the exhibition directory—distributed to all meeting registrants
- One complimentary registration to the technical sessions and exhibits
- Hosted welcoming reception in the exhibition area
- Hosted coffee and refreshment breaks in the exhibition area
- Post-show report of meeting participants
- Exhibition management services
- Booth: (1) eight-foot table, (2) chairs, standard electrical service

The program, audience and exhibition combine for an unsurpassed annual event in electronic materials.

Be there – reserve your exhibit space today online at www.tms.org/EMC.html or complete the form on page 69!

(Space reservations are accepted on a first-come, first-served basis. Cost is \$1,200 per booth space.)

Exhibition

Exhibiting Companies (as of 4/5/06)

Accent Optical Technologies
Allied High Tech Products Inc.
Applied Surface Technologies
Epichem Group
EXAKT Technologies Inc.
Intrinsic Semiconductor
k-Space Associates Inc.
Kurt J. Lesker Company
Lake Shore Cryotronics Inc.
MMR Technologies Inc.
Springer
SVT Associates Inc.
United Mineral & Chemical Corporation
Vacuum Barrier Corporation
Veeco Instruments Inc.
Wafer Technology Ltd.

Join this growing list of exhibitors today before the space is sold out!

Take Advantage of Corporate Sponsorship Opportunities at EMC!

As the exclusive sponsor of an activity at EMC, your company benefits from name and logo recognition through:

- Signage
- EMC Web Site
- Conference Promotional Materials
- Conference Program

Exclusive Sponsorship Activities

- Welcoming Reception
- Coffee Breaks
- Continental Breakfast
- Conference Social Event/Banquet

For more information on sponsorship or the exhibition, contact Cindy Wilson, TMS Exhibits Coordinator.

Telephone: (800) 759-4TMS or (724) 776-9000, ext. 231

Fax: (724) 776-3770

E-mail: wilson@tms.org

About the Location

Computer/Network Facilities

The Penn State Conference Center has complimentary wireless Internet access throughout the facility. Ethernet connections in the sleeping rooms are also complimentary; Ethernet cables are located at the front desk. Additionally, there are a limited number of computers available on level one to check e-mail on a complimentary basis.

Messages

A message board located near the on-site registration desk on the first level of the conference center will be available for use throughout the conference.

Dress

Casual clothing is in order with a sweater or light jacket occasionally needed for the evenings. Layered clothing is recommended for cooler days or in air-conditioned buildings. The average afternoon temperatures in June in the Nittany Valley reach the middle 80s °F (22-25°C); nighttime temperatures drop to between 55 and 65°F (13-15°C). Comfortable walking shoes, a light raincoat and an umbrella are also recommended.

Campus Smoking Policy

Pennsylvania State University prohibits smoking in all buildings, including residence halls. Smoking is permitted in designated areas outside.



Americans With Disabilities Act

TMS strongly supports the federal Americans with Disabilities Act (ADA) which prohibits discrimination against, and promotes public accessibility for, those with disabilities. In support of, and in compliance with, ADA, we ask those requiring specific equipment or services to indicate their needs on the enclosed housing form or contact TMS Meeting Services in advance.

Housing: On Campus

On-campus housing is available on a first-come, first-served basis; therefore, early registrations and reservations are essential.

Penn State residence halls and dining facilities are not located within walking distance to the session meeting rooms, which are located at the Penn Stater Conference Center. A daily shuttle will be provided for those staying in the residence halls. Residence hall accommodations are single occupancy only; all rooms have private restrooms. Lodging includes beds, made on arrival day, and daily room service with washcloth and towel change. Unfortunately, there is no housing on campus accommodating children. Alternative housing for those with children are the Penn Stater Conference Center Hotel or other hotels listed on page 12.

Penn State offers the following housing plans. We regret that no adjustments can be made for late arrivals or early departures.

Please indicate your plan preference on the enclosed reservation form on page 67 and return it with your payment by May 26, 2006. Reservations received by the deadline will be confirmed by the conference office.

Plan A: Check-in Tuesday / Check-out Friday

Includes continental breakfasts on Wednesday, Thursday and Friday
\$177 single occupancy

Plan B: Check-in Wednesday / Check-out Friday

Includes continental breakfasts on Thursday and Friday
\$118 single occupancy

Late Departure: Check-out Saturday (July 1)

Includes lodging Friday night and continental breakfast on Saturday
Additional night's rate: \$59 single occupancy

Commuter Lunch Package

Box lunches at the Penn Stater Conference Center must be purchased in advance on the enclosed registration form on page 65. The purchase of box lunches is recommended for all attendees, especially for those staying in the residence halls. The lunches will be available in the exhibition, located in Presidents Hall 1 & 2.

Three lunches: \$33

On-Campus Dining Hours

Pollock Commons Dining Hall

Breakfast 7 to 8 a.m. (cost included in on-campus housing plan)

Dinner 5:30 to 7 p.m. (\$10.50 per person)

Food facilities on campus close at 7 p.m.; downtown restaurants are only a short walk from the residence halls.

Housing: Hotels

Penn Stater Conference Center Hotel

A block of rooms has been reserved at a special conference rate at the Penn Stater Conference Center, where all EMC activities will take place. Rooms will be released as early as May 26. Thereafter, reservations can be obtained only as space is available. Attendees should make reservations directly with the hotel as soon as possible:

Penn Stater Conference Center
215 Innovation Boulevard
State College, PA 16803-6603
Telephone: (814) 863-5000
Fax: (814) 863-5003

Rooms are available at the special EMC rate for Tuesday through Thursday nights; individuals must identify themselves as EMC attendees to receive the special rate. Friday or Saturday night stays are available if requested at the time the reservation is made. Please note that the listed rates do not include tax.

Rate: \$85/single or \$95/double occupancy (For double accommodation, attendee must book with a roommate.*)

Free parking is available as well as a full-service restaurant, indoor lap pool and whirlpool.

Conference Code: EMC0627

*If you do not have a roommate at the time of your reservation, send a fax to Mike Packard at (724) 776-3770, and he will assign a roommate for the Penn Stater Conference Center. Provide the following information in the fax:

Your Name, Contact Information (address, telephone number, fax number), Arrival Date, Departure Date, Credit Card Information, Gender

Other Hotels

Individuals staying at any of the following hotels must arrange for their own transportation to and from the Penn Stater Conference Center.

Atherton (Downtown)

\$80 single/\$90 double occupancy

Telephone: (814) 231-2100

Conference Code: EMCEL270606

Hilton Garden Inn State College

\$89

Telephone: (814) 272-1221

Conference Code: EMC

Days Inn – Penn State

(Downtown)

\$77 single/\$87 double occupancy

Telephone: (814) 238-8454

Conference Code: EMC

Holiday Inn Express

\$89

Telephone: (814) 867-1800

Conference Code: EMC

Hampton Inn

Williamsburg Square

\$89

Telephone: (814) 231-1899

Conference Code: EMC

Nittany Lion Inn

\$98

Telephone: (814) 865-8500

Conference Code: EMC0628

(Limited shuttle service available to conference center)

**For evening dinner options,
visit www.lionsmenu.com
to learn about local restaurants!**

Transportation

Air

The following airlines have scheduled flights to State College:

Delta Airlines – jet services

Northwest Airlines – jet service and prop planes

United Airlines – jet service and prop planes

US Airways – jet service and prop planes

Airport Code: SCE

For more information, visit www.statecollegeairport.org

Taxis and Hotel Shuttles

Shuttles do not operate at the airport. Both the Nittany Lion Inn and The Penn Stater provide complimentary transports to and from the airport. Their guests can make arrangements in advance or at the airport by using the courtesy phone.

For direct lines to participating taxi services and hotel shuttles, check the airport phone board located near the baggage terminal.

AA Transit

Telephone: (814) 231-8294

Handy Delivery Taxi

Telephone: (814) 353-6001

Nittany Express Airport Shuttle

Telephone: (814) 867-4646 or
(814) 880-6234

Diamond Limousine

Telephone: (814) 364-1960

Tim Fischer's Limousine Service

Telephone: (814) 234-3335

VIP Limo (Fullington)

Telephone: (800) 435-6556

Transportation

Parking

Parking at the Penn Stater Conference Center is complimentary. Overnight parking at the campus residence halls is \$21 for the week.

Car

Additional major airports and Map Quest driving times under 4 hours:

Harrisburg International.....	2 hours
Pittsburgh International.....	3.25 hours
Baltimore-Washington International	3.5 hours
Philadelphia International	3.75 hours
Washington Dulles International	3.75 hours



Official Car Rental Company of the TMS 2006 Electronic Materials Conference

Meeting rates are guaranteed for a period beginning one week prior to the conference through one week after and are subject to car availability. Rates are available from all Hertz locations in Pennsylvania.

Advance reservations are recommended and may be made by booking online at www.hertz.com or calling the Hertz reservations line at (800) 654-2240 in the U.S. or (800) 263-0600 in Canada. International customers should contact the nearest Hertz reservation center or call +1-405-749-4434. Travelers must identify themselves as attendees of EMC and reference CV#02QJ0019 in order to receive the special rates.

Terms and Conditions

- Unlimited mileage allowance
- One-way service fee applies when cars are not returned to renting location.
- Additional daily charges for optional coverage (Loss Damage Waiver, Personal Accident Insurance, Personal Effect Protection, refueling and state tax) are not included in the listed rates.
- Drivers must meet standard Hertz age, driver and credit requirements.
- Hertz is a frequent flyer partner with US Airways, Delta, Northwest, United, and American Airlines. Frequent flyer information may be requested at time of car booking.
- Weekly rentals are from five to seven days. Weekend rentals have a minimum two-day keep, and Thursday pick-up requires a minimum three-day keep.

Recreation

Visit these attractions on Penn State's campus!

Old Main

Founded in 1855, Penn State is Pennsylvania's land-grant institution. Old Main, the chief administrative building, contains frescoes by artist Henry Varnam Poor showing the growth of the university.

University Creamery

Penn State retains its leadership in agricultural sciences. Many visitors stop by the University Creamery for ice cream made on-site.

Museums

Matson Museum of Anthropology
Earth and Mineral Sciences Museum
Frost Entomological Museum
Palmer Museum of Art

Sporting Facilities

Blue and White Golf Course (36 holes)
Tennis Courts
Indoor Tracks
Exercise and Fitness Centers
Indoor Ice Skating Rink
Swimming Pools

Hiking and Bird Watching

Shaver's Creek Environmental Center
Stone Valley Recreation Area

Nittany Lion Shrine

Located near the Nittany Lion Inn, the shrine was a gift of the Class of 1940 and is the university's most photographed landmark.

Or travel to these nearby sites!

Penn's Cave

Take a one-mile boat tour through America's only all-water cavern and visit the animal preserve.

Bellefonte Historical Railroad

Enjoy a leisurely trip through the Nittany Valley.

Pennsylvania Military Museum in Boalsburg

The history of America's citizen soldiers is preserved in this museum, surrounded by quaint shops and antique emporiums in Boalsburg, Lemont, and Centre Hall. These shops feature the works of local artists and craftspeople.

Proceedings/Publications

EMC does not publish formal conference proceedings; however, conference abstracts are published in the *Journal of Electronic Materials* (*JEM*) throughout the year. *JEM* encourages both presenters and attendees to submit manuscripts of their work.

A special issue on Group III Nitrides, SiC and ZnO is planned for early 2007. Papers are due August 1, 2006, and may be submitted through the *JEM* Web site at <http://jem.msubmit.net>.

About *JEM*

JEM is a monthly archival journal of TMS and the Institute of Electrical and Electronics Engineers (IEEE). Articles are reviewed, selected and edited by peers who serve as voluntary members of the editorial board, the board of associate editors, or section editors.

JEM's Content

JEM is a forum for the rapid circulation of the results of original research.

It contains technical papers detailing critical new developments in the electronics field, as well as invited and contributed review papers on topics of current interest. The journal focuses on electronic memory and logic structures, magnetic-optical recording media, superlattices, packaging, detectors, emitters, metallization technology, superconductors, and low thermal-budget processing and includes general papers on electronic materials for device application, structure making, reliability and yield. Articles on methods for preparing and evaluating the chemical, physical and electronic properties of electronic materials are also included.



JEM Subscription for Attendees

Attendees may include the cost of a 2007 subscription to *JEM* on the registration form. The 2007 journals will include manuscripts of papers presented at the 2006 EMC. After the conference, individuals may subscribe to *JEM* through the online TMS Document Center at <http://doc.tms.org> at the standard rates.

Manuscript Submission

JEM employs an online manuscript submission and review system. To be considered for publication, authors must submit manuscripts electronically. Detailed submission guidelines are available from the *JEM* Web site at <http://jem.msubmit.net>.

Proceedings/Publications

Look for these electronic materials related publications in the TMS Document Center!

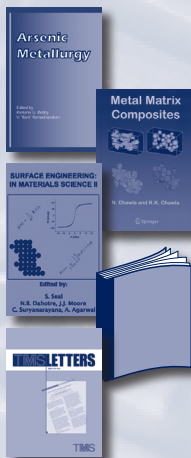
Arsenic Metallurgy

Metal Matrix Composites

**Surface Engineering:
Science and Technology II**

**Surfaces and Interfaces in
Nanostructured
Materials and Trends in LIGA,
Miniaturization, and
Nanoscale Materials**

TMS Letters (2004)



Special Issues of Journal of Electronic Materials:

- Microstructures and Textures of Films and Coatings in Electronic Applications (December 2005)
- 2004 U.S. Workshop on the Physics and Chemistry of II-VI Materials (June 2005)
- Challenges in Advanced Thin Films: Microstructures, Interfaces and Reactions (May 2005)
- SiC and the Group III Nitride Semiconductors (April 2005)
- Lead-Free Solders and Processing Issues Relevant to Microelectronic Packaging (December 2004)
- Nanostructured Magnetic Materials: Recent Progress in Magnetic Nanostructures (November 2004)
- Phase Stability, Phase Transformations and Reactive Phase Formation in Electronic Materials III (October 2004)
- III-V Nitrides and Silicon Carbide (May 2004)

For other publications or to order:

Visit the TMS Document Center online at <http://doc.tms.org>, e-mail publications@tms.org or telephone (800) 759-4TMS, ext. 251.

Conference Organizers

Electronic Materials Committee Officers

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*University of California,
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William Schaff
Cornell University

Christian M. Wetzel
Uniroyal Optoelectronics

Glenn Solomon
Stanford University

Jerry M. Woodall
Purdue University

Invited Organizers

EMC thanks the following invited organizers for their support and contribution to this year's technical program:

Shigefusa Chichibu
University of Tsukuba

Debdeep Jena
University of Notre Dame

Russell Dupuis
Georgia Institute of Technology

Kei-May Lau
*Hong Kong University of
Science & Technology*

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Carnegie Mellon University

Pat Lenahan
Pennsylvania State University

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IBM Corporation

Maria Losurdo
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Methodologies and Plasmas*

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Charles Lutz
Kopin Corporation

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Peter Moran
*Michigan Technological
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NASA Ames Research Center

Alec Talin
Sandia National Laboratories

David Norton
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University of Tokyo

Robert Okojie
NASA Glenn Research Center

Michael Tischler
Ocis Technologies

Sarah Olsen
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Newcastle-Upon-Tyne*

Raymond Tsui
Motorola

Jamie Phillips
University of Michigan

Lloyd Whitman
Naval Research Laboratory

Klaus Ploog
*Paul Drude Institute for Solid
State Electronics*

David Wilt
NASA Glenn Research Center

Steve Ringel
Ohio State University

Shalom Wind
Columbia University

Alberto Salleo
Palo Alto Research Center

William Wong
Palo Alto Research Center

Nitin Samarth
Pennsylvania State University

Michael Wraback
US Army Research Laboratory

Tae-Yeon Seong
*Kwangju Institute of
Science & Technology*

Ya-Hong Xie
University of California

Ben Shanabrook
Naval Research Laboratory

Grace Huili Xing
University of Notre Dame

PRELIMINARY SCHEDULE OF EVENTS 48TH TMS ELECTRONIC MATERIALS CONFERENCE

TUESDAY, JUNE 27, 2006

Registration.....3:00 PM-5:00 PM
Location.....Penn Stater Conference Center Lobby

WEDNESDAY, JUNE 28, 2006

Registration.....7:00 AM-5:00 PM
Location.....Penn Stater Conference Center Lobby
Exhibition.....9:30 AM-4:00 PM & 6:00 PM-8:00 PM
Location.....Presidents Hall I & II - Main Level
Welcome Reception.....6:00 PM-8:00 PM
Location.....Presidents Hall III & IV - Main Level

SESSIONS

Plenary Session.....8:20 AM
(Including Student Awards Ceremony)
Location.....Presidents Hall III & IV
Session A. ZnO Nanomaterials.....10:00 AM
Session B. III-Nitride Optoelectronic Devices.....10:00 AM
Session C. Narrow Bandgap Semiconductors.....10:00 AM
Session D. Fun with Nanostructures.....10:00 AM
Session E. Nitride and Oxide Nanowires.....10:00 AM
Session F. Directed Assembly of Nanostructures.....1:30 PM
Session G. Quantum Dot Growth.....3:30 PM
Session H. III-Nitride Electronic Devices.....1:30 PM
Session I. Materials Integration: Wafer Bonding and
Alternative Substrates.....1:30 PM
Session J. Nanotubes.....1:30 PM
Session K. Chemical and Biological Sensors I.....1:30 PM
Session L. Contacts to Organic Thin Film Transistors.....3:30 PM
Session M. Oxide Thin Film Integration I.....1:30 PM
Session N. GaN Processing.....1:30 PM
Session O. Semiconductors: Processing and Oxidation.....3:30 PM

THURSDAY, JUNE 29, 2006

Registration.....7:00 AM-4:00 PM
Location.....Penn Stater Conference Center Lobby
Exhibition.....9:00 AM-3:30 PM
Location.....Presidents Hall I & II - Main Level
Banquet.....6:00 PM-9:00 PM
Location.....Beaver Stadium

SESSIONS

Session P. Device Aspects for ZnO.....8:20 AM
Session Q. III-Nitride MOCVD Growth.....8:20 AM

Session R. Lattice Engineered Epitaxy of III-V and IV Semiconductors.....	8:20 AM
Session S. SiC: Growth and Interface Studies.....	8:20 AM
Session T. Materials and Processing for Organic Transistors.....	8:20 AM
Session U. Oxide Thin Film Integration II.....	8:20 AM
Session V. Non-Destructive Testing and In-Situ Monitoring and Control.....	8:20 AM
Session W. ZnO Growth.....	1:30 PM
Session X. MBE Growth of Group III-Nitrides.....	1:30 PM
Session Y. Epitaxy for Devices.....	1:30 PM
Session Z. SiC: Characterization.....	1:30 PM
Session AA. Organic/Inorganic Hybrid Photovoltaics.....	1:30 PM
Session BB. Oxide Thin Film Integration III.....	1:30 PM
Session CC. Dilute Nitride Semiconductors.....	1:30 PM

FRIDAY, JUNE 30, 2006

Registration.....	7:00 AM-10:00 AM
Location.....	Penn Stater Conference Center Lobby

SESSIONS

Session DD. P-Type Doping and Electroluminescence in ZnO.....	8:20 AM
Session EE. Contacts to III-Nitrides.....	8:20 AM
Session FF. Indium Nitride.....	8:20 AM
Session GG. Silicon and Germanium Nanowires.....	8:20 AM
Session HH. Molecular Electronics: Devices, Materials and Contacts.....	8:20 AM
Session II. Trapping and Charge Transport in Organic Transistors.....	8:20 AM
Session JJ. Spintronic Materials.....	8:20 AM
Session KK. GaN Characterization.....	1:30 PM
Session LL. Compound Semiconductor Nanowires.....	1:30 PM
Session MM. Chemical and Biological Sensors II.....	1:30 PM

EMC Plenary Lecture/Student Awards

Ceremony: 8:20 AM

Room: Presidents Hall III & IV

Plenary Speaker: Arthur C. Gossard, University of California,
Santa Barbara

Topic: Growth and Uses of Metal/Semiconductor Heterostructures

Break: 9:20 AM - 10:00 AM

Session A: ZnO Nanomaterials

Wednesday AM Room: Presidents Hall III
June 28, 2006 Location: Pennsylvania State University

Session Chairs: Yicheng Lu, Rutgers University; David P. Norton,
University of Florida

10:00 AM Student

A1, Undoped and Doped ZnO Nanorods: *Jinkyoungh Yoo*¹; Gyu-Chul Yi¹;
¹POSTECH

10:20 AM Student

A2, Spatially-Dependent Optical Emission from ZnO Nanotips on Al₂O₃ and Si Substrates: *Lei Fang*¹; Yuri Strzhemechny²; Michael J. Hetzer¹; Leonard J. Brillson¹; H. Chen³; Yicheng Lu³; ¹Ohio State University; ²Texas Christian University; ³Rutgers University

10:40 AM Student

A3, Selective Growth of Zinc Oxide Nanowires Grown from Thin Film Multilayer Structure for Shadow Lithography: Bing Hu¹; Pawan Tyagi¹; *Bruce J. Hinds*¹; ¹University of Kentucky

11:00 AM

A4, Piezoelectric and Electrical Properties of Solution Grown ZnO Nanorods: *David Scrymgeour*¹; Thomas L. Sounart¹; Neil C. Simmons¹; Yun-Ju Lee¹; Paul G. Clem¹; Julia W. P. Hsu¹; ¹Sandia National Laboratory

11:20 AM

A5, ZnO/ZnMgO Quantum Wells Embedded in Nanorods: *Andrey Bakin*¹; Abdel-Hamid El Shaer¹; Augustine Che Mofor¹; Muhamed Aid Mansur Al-Suleiman¹; Sergey Ivanov²; Johannis Stoimenos³; Andreas Waag¹; ¹Technical University Braunschweig; ²Ioffe Physico-Technical Institute of RAS; ³Aristotele University

11:40 AM

A6, Catalyst-Free Two-Step Growth of Quasi-Aligned ZnMgO Nanorods and Their Properties: *Liping Zhu*¹; Mingjia Zhi¹; Zhizhen Ye¹; ¹Zhejiang University

Session B: III-Nitride Optoelectronic Devices

Wednesday AM Room: Presidents Hall IV
June 28, 2006 Location: Pennsylvania State University

Session Chairs: Russell Dupuis, Georgia Institute of Technology;
Andrew Allerman, Sandia National Laboratories

10:00 AM Student

B1, Growth and Characterization of High-Performance III-N Avalanche Photodiodes Grown on Bulk GaN Substrates: *Jae Limb*¹; Dongwon Yoo¹; Jae-Hyun Ryou¹; Wonseok Lee¹; Shyh-Chiang Shen¹; Meredith Reed²; Charles J. Collins²; Michael Wraback²; Drew Hanser³; Edward Preble³; N. Mark Williams³; Keith Evans³; Russell Dupuis¹; ¹Georgia Institute of Technology; ²US Army Research Laboratory; ³Kyma Technologies, Inc.

10:20 AM Student

B2, MOCVD Growth of AlGaIn Heterostructures and UV LEDs on Bulk AlN Substrates: *Zaiyuan Ren*¹; Qian Sun¹; Soon-Yong Kwon¹; Jung Han¹; Kristina Davitt²; Yoon-Kyu Song²; Arto Nurmikko²; Wayne Liu³; Joe Smart³; Leo Schowalter³; ¹Yale University; ²Brown University; ³Crystal IS Inc.

10:40 AM Student

B3, Characterization of Green LED Structures with p-InGaIn and p-GaN Layers: *Wonseok Lee*¹; Jae Limb¹; Jae-Hyun Ryou¹; Dongwon Yoo¹; Michael Stevens²; Sridhar Srinivasan²; Fernando Ponce²; Russell Dupuis¹; ¹Georgia Institute of Technology; ²Arizona State University

11:00 AM Student

B4, High Light-Extraction Efficiency in GaInN Light-Emitting Diode with Pyramid Reflector: *J.-Q. Xi*¹; Alyssa J. Pasquale¹; Jong Kyu Kim¹; Hong Luo¹; E. F. Schubert¹; ¹Rensselaer Polytechnic Institute

11:20 AM Student

B5, Temperature Dependence of the Quantum Efficiency in Green and Deep Green GaInN/GaN Light Emitting Diodes: *Yufeng Li*¹; W. Zhao¹; Y. Xia¹; M. Zhu¹; T. Detchprohm¹; E. F. Schubert¹; C. Wetzel¹; ¹Rensselaer Polytechnic Institute

11:40 AM Student

B6, Nitride-Based Type-II InGaIn-GaNAs 'W' Quantum Well Gain Media at 420-550 nm: *Ronald A. Arif*¹; Yik-Khoon Ee¹; Nelson Tansu¹; ¹Lehigh University

Session C: Narrow Bandgap Semiconductors

Wednesday AM Room: Conference Room 106
June 28, 2006 Location: Pennsylvania State University

Session Chairs: Brian R. Bennett, Naval Research Laboratory; L. Ralph Dawson, University of New Mexico

10:00 AM

C1, Carrier Recombination Kinetics in 2.3-2.4 μ m InGaAsSb/AlGaAsSb QW Laser Heterostructures: *Dmitri Donetsky*¹; Leon Shterengas¹; George Kim²; Gregory Belenky¹; Alex Gourevitch¹; David Westerfeld³; Ray

Martinelli²; ¹Stony Brook University; ²Sarnoff Corporation; ³Power Photonic Corporation

10:20 AM

C2, Electron and Hole Energy Relaxation in InGaAsSb/InAs/InGaSb Type-II QW Laser Heterostructures: Leon Shterengas¹; Andrew Ongstad²; Ron Kaspi²; Serge Suchalkin¹; Gregory Belenky¹; Michail Kisin¹; *Dmitri Donetsky*¹; ¹Stony Brook University; ²Air Force Research Laboratory

10:40 AM

C3, Improved Properties of MOCVD Grown InAs/GaSb Superlattices on (001) GaSb Substrate by Introducing an InAsSb Layer at the Interfaces: *Xue-Bing Zhang*¹; C. Xu²; Shin Mou²; Jae-Hyun Ryou¹; K. C. Hsieh²; Shun-Lien Chuang²; Russell Dupuis¹; ¹Georgia Institute of Technology; ²University of Illinois at Urbana-Champaign

11:00 AM Student

C4, Effects of Ga and Sb Precursor Chemistry on the Alloy Composition in Pseudomorphically Strained GaAsSb Films Grown via Metalorganic Vapor Phase Epitaxy: *A. A. Khandekar*¹; J. Y. Yeh¹; L. J. Mawst¹; Xueyan Song¹; S. E. Babcock¹; T. F. Kuech¹; ¹University of Wisconsin

11:20 AM Student

C5, Island Size and Development of Systematic Crystallographic Tilt during Growth of InAs on (100) GaAs Substrates: *Suryanarayanan Ganesan*¹; Anish A. Khandekar¹; Manish Rathi¹; Joshua Webb¹; Thomas F. Kuech¹; Susan E. Babcock¹; ¹University of Wisconsin-Madison

11:40 AM Student

C6, Growth Mechanisms for InAs Deposition on Low Index GaAs Substrates by Metalorganic Vapor Phase Epitaxy: *A. A. Khandekar*¹; J. Webb¹; G. Suryanarayanan¹; M. Rathi¹; S. Babcock¹; T. F. Kuech¹; ¹University of Wisconsin-Madison

Session D: Fun with Nanostructures

Wednesday AM Room: Conference Room 208
June 28, 2006 Location: Pennsylvania State University

Session Chairs: Glenn S. Solomon, National Institute of Standards and Technology; Ben Shanabrook, Naval Research Laboratory

10:00 AM

D1, Structural and Optical Studies of Quantum Dot Molecules: *Valeria G. Stoleru*¹; Anup Pancholi¹; William Kerr¹; Hassan Shah¹; ¹University of Delaware

10:20 AM Student

D2, Fluorescence Intermittency of Localized Excitons in CdSe Nanowires: *Vladimir Protasenko*¹; Masaru Kuno¹; ¹University of Notre Dame

10:40 AM

D3, Discrimination of Isoelectronic Centers and Type-II Quantum Dots with ZnTe Embedded in ZnSe: *Masafumi Jo*¹; Michiaki Endo¹; Hidekazu Kumano¹; Ikuo Suemune¹; ¹Hokkaido University

11:00 AM

D4, Thermoelectric Properties of Vertically Aligned InAs/GaAs Quantum Dot Superlattices: *Abhishek Yadav*¹; Kevin Pipe¹; Weifeng Ye¹; Rachel S. Goldman¹; ¹University of Michigan

11:20 AM Student

D5, Fabrication of High Frequency Ultrasound Transducers: *Hyunsoo Kim*¹; Sungkyu Park¹; Ioanna Mina²; Insoo Kim³; S. Bharadwaja²; X. Li⁴; Kyusun Choi³; Susan Trolrier-Mckinstry²; Richard Tutwiler⁵; Theresa Mayer⁴; Thomas N. Jackson¹; ¹Pennsylvania State/Center for Thin Film Devices and Materials Research Institute; ²Pennsylvania State/Material Science and Engineering; ³Pennsylvania State/Computer Science and Engineering; ⁴Pennsylvania State/Electrical Engineering; ⁵Pennsylvania State/Applied Research Laboratory

11:40 AM

D6, Electron Energy Levels in ZnSe:Mn Quantum Dots: *Shailaja Mahamuni*¹; Amit D. Lad¹; Shashikant P. Patole¹; ¹University of Pune

Session E: Nitride and Oxide Nanowires

Wednesday AM Room: Conference Room 207
June 28, 2006 Location: Pennsylvania State University

Session Chair: Joan M. Redwing, Pennsylvania State University

10:00 AM

E1, Polarization-Resolved Photoluminescence Study of Isolated GaN Nanowires Grown by Catalyst-Free MBE: *John B. Schlager*¹; Norman A. Sanford¹; Kris A. Bertness¹; Joy M. Barker¹; Alexana Roshko¹; Paul T. Blanchard¹; ¹National Institute of Standards and Technology

10:20 AM

E2, Structural Control and Characterization of GaN Nanowires: *Blake S. Simpkins*¹; Pehr E. Pehrsson¹; ¹Naval Research Laboratory

10:40 AM Student

E3, Experimental and Computational Modeling Studies of MOCVD Growth of GaN Nanowires: *Robert A. Burke*¹; Daniel R. Lamborn¹; Trevor E. Clark¹; Elizabeth C. Dickey¹; Joan M. Redwing¹; ¹Pennsylvania State University

11:00 AM

E4, Epitaxial Growth and Applications of Aligned GaN Nanowires: *Kyungkon Kim*¹; Tania Henry¹; George Cui¹; Jung Han¹; Yoon-Kyu Song²; Arto V. Nurmikko²; ¹Yale University; ²Brown University

11:20 AM

E5, Growth and Characterization of Vanadium Oxide Nanowires: *Jongsun Maeng*¹; Takhee Lee¹; ¹Gwangju Institute of Science and Technology

11:40 AM Student

E6, Integration and Characterization of High Aspect Ratio Ferroelectric Microtubes Fabricated by Vacuum Infiltration of Macroporous Silicon Templates: *Xin Li*¹; S. S. N. Bharadwaja¹; N. Bassiri Gharb¹; E. Hong¹; M. Olszta¹; F. Roozeboom¹; Theresa S. Mayer¹; Susan Trolrier McKinstry¹; ¹Pennsylvania State University

Session F: Directed Assembly of Nanostructures

Wednesday PM Room: Presidents Hall III
June 28, 2006 Location: Pennsylvania State University

Session Chairs: Diana Huffaker, University of New Mexico; Ben Shanabrook, Naval Research Laboratory

1:30 PM Student

F1, Selective Growth and Characterization of GaAs Quantum Dots on Patterned Substrate by Utilizing Diblock Copolymer Template: *Joo Hyung Park*¹; Anish Arun Khandekar¹; Sang-Min Park¹; Luke J. Mawst¹; Thomas F. Kuech¹; Paul F. Nealey¹; ¹University of Wisconsin-Madison

1:50 PM Student

F2, Simulation of Thermal-Field Directed Self-Assembly of Epitaxial Quantum Dots: *Chandan Kumar*¹; Lawrence H. Friedman¹; ¹Pennsylvania State University

2:10 PM Student

F3, Real-Time Studies of Ga Droplet Formation for the Directed Seeding of Semiconductor Nanopillars: *Weifeng Ye*¹; Ben L. Cardozo¹; Xiaojun Weng²; John F. Mansfield¹; Rachel S. Goldman¹; ¹University of Michigan; ²Pennsylvania State University

2:30 PM

F4, Self-Assembly of Heterojunction Quantum Dots(HeQuADs): *Kurt G. Eyink*¹; David H. Tomich¹; Jeremy J. Pitz¹; Krishnamurthy Mahalingam²; J. M. Shank³; S. Munshi¹; Bruno Ulrich⁴; Wally Rice⁵; ¹Air Force Research Laboratory; ²Universal Technology Corporation; ³Southwestern Ohio Council for Higher Education; ⁴Bowling Green University; ⁵Wright State University

2:50 PM

F5, Fabrication of Nanometer-Period Gratings on Si Using HSQ Etching Mask: *Niu Jin*¹; Vipam Kumar¹; Sookyung Choi¹; Mark Shannon¹; Ilesanmi Adesida¹; ¹University of Illinois

3:10 PM Break

Session G: Quantum Dot Growth

Wednesday PM Room: Presidents Hall III
June 28, 2006 Location: Pennsylvania State University

Session Chairs: Ben Shanabrook, Naval Research Laboratory; Diana Huffaker, University of New Mexico

3:30 PM Student

G1, Growth of High Quality Stranaky-Krastanov GaSb Quantum Dots on a GaAs Substrate: *Ganesh Balakrishnan*¹; Shenghong Huang¹; Arezou Khoshakhlagh¹; Anitha Jallipalli¹; Jun Tatebayashi¹; L. R. Dawson¹; D. L. Huffaker¹; ¹University of New Mexico

3:50 PM Student

G2, Characteristics of InGaAs/GaAs(P) Quantum Dot Stacks Grown by MOCVD: *Nam-Heon Kim*¹; Gene Tsvi¹; Anish A. Khandekar¹; Luke J. Mawst¹; Thomas F. Kuech¹; Manoj Kanskar²; ¹University of Wisconsin-Madison; ²Alfalight Inc.

4:10 PM

G3, Influence of Strain Modulations in Capping Layers of InAs Quantum Dots with Compressive-InGaAs and Tensile-GaAsN Layer Structures: Wei Zhang¹; Katsuhiko Uesugi¹; *Ikuo Suemune*¹; ¹Hokkaido University

4:30 PM Student

G4, Growth of High Density InAs Quantum Dots by Metalorganic Chemical Vapor Deposition with Periodic Interruption of AsH₃: *Youngsoo Lee*¹; Eungjin Ahn¹; Jungsub Kim¹; Pilkyung Moon¹; Euijoon Yoon¹; ¹Seoul National University

4:50 PM

G5, Late News

Session H: III-Nitride Electronic Devices

Wednesday PM Room: Presidents Hall IV
June 28, 2006 Location: Pennsylvania State University

Session Chairs: Russell Dupuis, Georgia Institute of Technology;
April S. Brown, Duke University

1:30 PM

H1, Growth and Characterization of Graded InGaN Heterojunction Bipolar Transistors: Theodore Chung¹; David Keogh²; Dongwon Yoo¹; *Jae-Hyun Ryou*¹; Jae Limb¹; Wonseok Lee¹; Shyh-Chiang Shen¹; Peter Asbeck²; Russell Dupuis¹; ¹Georgia Institute of Technology; ²University of California, San Diego

1:50 PM Student

H2, Device Performance of Full-Vertical GaN *p-i-n* Rectifiers Using Conducting Buffer Layers on SiC Substrates: *Dongwon Yoo*¹; Jae Boum Limb¹; Jae-Hyun Ryou¹; Wonseok Lee¹; Russell Dupuis¹; ¹Georgia Institute of Technology

2:10 PM Student

H3, EBIC and XPS Study of Post-Annealing Process on AlGaIn/GaN Schottky Diodes: *Hyeongnam Kim*¹; Michael Schuette¹; Hyunchul Jung¹; Junghui Song¹; Jaesun Lee¹; Wu Lu¹; James C. Mabon²; ¹Ohio State University; ²Material Research Laboratory

2:30 PM

H4, Gate Dielectric Considerations for Scaleable III-V MOS Structures: *Mark Johnson*¹; J. A. Grenko¹; Y. N. Saripalli¹; D. W. Barlage¹; Y. Jin¹; Dave Braddock²; ¹North Carolina State University; ²OSEMI, Inc.

2:50 PM Student

H5, Fabrication and Characterization of Enhancement-Mode n-Channel GaN MOSFETs: *Weixiao Huang*¹; Tahir Khan¹; T. Paul Chow¹; ¹Rensselaer Polytechnic Institute

3:10 PM Break

3:30 PM

H6, Spin-Orbit Quantum Interference and Dephasing in High Mobility GaN/AlGaIn Heterostructures: *Michael Manfra*¹; Stefan Schmult¹; Alex Punnoose¹; Richard Molnar²; ¹Bell Laboratories; ²Massachusetts Institute of Technology Lincoln Laboratory

3:50 PM

H7, Transport Characterization of AlGaIn/GaN Heterostructures Grown on SiC: *Said Elhamri*¹; William C. Mitchel²; William D. Mitchell²; Rex Berney¹; Adam Saxler³; ¹University of Dayton; ²Air Force Research Laboratory; ³Cree, Inc.

4:10 PM Student

H8, High Voltage AlGaIn/GaN HFETs with Fe-Doped GaN Buffer on Silicon Substrate: *Young Chul Choi*¹; Milan Pophristic²; Ho-Young Cha³; Boris Peres²; Michael G. Spencer¹; Lester F. Eastman¹; ¹Cornell University; ²Velox Semiconductor Company; ³GE Global Research

4:30 PM Student

H9, Effects of UHV Surface Preparation and Gate Deposition on AlGaIn/GaN HEMT Device Performance: *Dennis E. Walker, Jr.*¹; Robert C. Fitch²; James K. Gillespie²; Gregg H. Jessen²; Leonard J. Brillson¹; ¹Ohio State University; ²Air Force Research Laboratory

4:50 PM Student

H10, Growth and Characterization of (AlN)_x(Si₃N₄)_{1-x} Thin Films for the Passivation of AlGaIn/GaN HEMT Structures: *Richard J. Brown*¹; James R. Shealy¹; ¹Cornell University

Session I: Materials Integration: Wafer Bonding and Alternative Substrates

Wednesday PM Room: Conference Room 106
June 28, 2006 Location: Pennsylvania State University

Session Chairs: Peter D. Moran, Michigan Technological University; Karl Hobart, Naval Research Laboratory

1:30 PM

I1, Exfoliation Temperature Dependence on Hydrogen Exfoliated Layer Properties: *Sumiko L. Hayashi*¹; Rajinder Sandhu²; Mark S. Goorsky¹; ¹University of California, Los Angeles; ²Northrop Grumman Space Technology

1:50 PM Student

I2, Interfacial Chemistry of InP/GaAs Bonded Pairs: *Ning Liu*¹; Thomas F. Kuech¹; ¹University of Wisconsin-Madison

2:10 PM Student

I3, Dislocation-Gettering in Hydrogen-Induced Exfoliation of Metamorphic InAs Epilayers: *Atif M. Noori*¹; Sumiko Hayashi¹; Rajinder Sandhu²; Abdullah Cavus²; Vincent Gambin²; Augusto Gutierrez-Aitken²; Mark Goorsky¹; ¹University of California, Los Angeles; ²Northrop Grumman Space Technology

2:30 PM

I4, Ultra-High Vacuum-Wafer Direct Bonding of III-V Compounds Semiconductors to Si-Wafer Using Low Energy (300 eV) Hydrogen Ion Beam Surface Cleaning: *N. Razek*¹; A. Schindler¹; B. Rauschenbach¹; ¹Leibniz-Institut für Oberflächenmodifizierung

2:50 PM Student

I5, Stress Analysis of Transferred Thin-GaN Light Emitting Diode by Au-Si Wafer Bonding: *Shih-Chieh Hsu*¹; Cheng-Yi Liu¹; ¹National Central University

3:10 PM Break

3:30 PM

16, Copper Interconnect Bonding for Polymer Pillar I/O Interconnects and Three-Dimensional (3D) Integration Application: *Kuan-Neng Chen*¹; Muhannad S. Bakir²; James D. Meindl²; Rafael Reif¹; ¹Massachusetts Institute of Technology; ²Georgia Institute of Technology

3:50 PM Student

17, Fabrication of Poly-Silicon TFT on Flexible Thin Glass Substrate: *Yoochul Jung*¹; Sunghwan Won¹; Dieter G. Ast¹; ¹Cornell University

4:10 PM Student

18, Built-In Strain in Silicon Nitride Films on Polymer Foils: *Alex Z. Kattamis*¹; I-Chun Cheng¹; Ke Long¹; James C. Sturm¹; Sigurd Wagner¹; ¹Princeton University

4:30 PM

19, Digital Lithographically Patterned Fine-Features for Flexible Thin-Film Transistor Array Backplanes: *William S. Wong*¹; Scott Limb¹; Eugene Chow¹; Michael Chabiny¹; Rene Lujan¹; Beverly Russo¹; ¹Palo Alto Research Center

4:50 PM

110, Late News

Session J: Nanotubes

Wednesday PM

Room: Conference Room 208

June 28, 2006

Location: Pennsylvania State University

Session Chair: Ray Tsui, Motorola Laboratories; Alec Talin, Sandia National Laboratories

1:30 PM

J1, Thin Film Transistors from Transparent Conducting Single-Wall Carbon Nanotube Networks: *Giovanni Fanchini*¹; Husnu Emrah Unalan¹; Manish Chhowalla¹; ¹Rutgers University

1:50 PM

J2, Carbon Nanotube Single-Electron Transistors Fabricated with Focused-Ion-Beam Technique: *Kenzo Maehashi*¹; Hirokazu Ozaki¹; Yasuhide Ohno¹; Koichi Inoue¹; Kazuhiko Matsumoto¹; Shu Seki¹; Seiichi Tagawa¹; ¹Osaka University

2:10 PM

J3, Contact Metallization Process for Vertical Carbon Nanotube Arrays Templated in Porous Anodic Alumina: *Aaron Franklin*¹; Matthew R. Maschmann¹; Manuel DaSilva¹; Timothy D. Sands¹; Timothy S. Fisher¹; David B. Janes¹; ¹Purdue University

2:30 PM

J4, Field Emission Induced UV Electroluminescence from Atomic Layer Deposition ZnO Coated Carbon Nanotubes: *John F. Conley*¹; Joshua M. Greene²; Lifeng Dong²; Jun Jiao²; Yoshi Ono¹; ¹Sharp Laboratories of America; ²Portland State University

2:50 PM Student

J5, Characterization and Application of Transparent and Conductive Single Walled Carbon Nanotube Thin Films: *Husnu Unalan*¹; Aurelien Du Pasquier¹; Giovanni Fanchini¹; Manish Chhowalla¹; ¹Rutgers University

3:10 PM Break

3:30 PM Student

J6, Precise Control of Number of Carbon Nanotube Growth by Digital Growth Process: *Masatoshi Maeda*¹; Takafumi Kamimura²; Kazuhiko

Matsumoto²; ¹University of Tsukuba; ²Osaka University

3:50 PM Student

J7, Assemblies of Single Wall Carbon Nanotubes and Unencapsulated Sub-10 nm Gold Nanoparticles: *Qingling Hang*¹; Matt Maschmann¹; Timothy S. Fisher¹; David B. Janes¹; ¹Purdue University

4:10 PM Student

J8, Characterization of the Field Emission Properties of Carbon Nanotube Films Formed on Silicon Carbide Substrates by Surface Decomposition: *Michael C. Pochet*¹; James A. Fellows¹; John J. Boeckl²; ¹Air Force Institute of Technology; ²Air Force Research Laboratory/Materials and Manufacturing Directorate

4:30 PM

J9, Oxygen Effects on Formation of Carbon Nanotube Structure in SiC Decomposition: Weijie Lu¹; *Senthil N. Sambandam*¹; John Rigueur¹; Warren E. Collins¹; John J. Boeckl²; William C. Mitchel²; ¹Fisk University; ²Air Force Research Laboratory

4:50 PM

J10, Late News

Session K: Chemical and Biological Sensors I

Wednesday PM Room: Conference Room 207

June 28, 2006 Location: Pennsylvania State University

Session Chairs: Stephen W. Howell, Sandia National Laboratories; David B. Janes, Purdue University

1:30 PM

K1, Large Area, Dense Si Nanowire Array Chemical Sensors: *Alec Talin*¹; Luke Hunter¹; Francois Leonard¹; Rokad Bhavin²; Blake Simmons¹; ¹Sandia National Laboratories; ²Cornell University

1:50 PM

K2, A Self-Assembling Semiconductor Nanowire-Based Pathogen Detection System: *Debdeep Jena*¹; Ronghui Zhou¹; Hsueh-Chia Chang¹; Masaru Kuno¹; ¹University of Notre Dame

2:10 PM

K3, Trace Chemical Detection Using Single-Walled Carbon Nanotubes: *Joshua A. Robinson*¹; Eric Snow¹; F. Keith Perkins¹; ¹Naval Research Laboratory

2:30 PM Student

K4, High-Sensitive Detection of Immunoglobulin E Using Aptamer-Modified Carbon Nanotube Field-Effect Transistors: *Taiji Katsura*¹; Kenzo Maehashi¹; Kazuhiko Matsumoto¹; Kagan Kerman²; Yuzuru Takamura²; Eiichi Tamiya²; ¹Osaka University; ²Japan Advanced Institute of Science and Technology

2:50 PM

K5, Real-Time Sensing of Proteins by Using a Top-Gate CNT-FET Biosensor: *Masuhiko Abe*¹; Katsuyuki Murata²; Atsuhiko Kojima³; Yasuo Ifuku⁴; Mitsuaki Shimizu⁵; Tatsuki Ataka¹; Kazuhiko Matsumoto⁶; ¹Olympus Corporation, NEDO; ²Olympus Corporation, NEDO, CREST-JST; ³CREST-JST, Mitsubishi Kagaku; ⁴Mitsubishi Kagaku Iatron; ⁵AIST; ⁶AIST, Osaka University, CREST-JST

3:10 PM Break

Session L: Contacts to Organic Thin Film Transistors

Wednesday PM Room: Conference Room 207
June 28, 2006 Location: Pennsylvania State University

Session Chairs: Max Shtein, University of Michigan; Alberto Salleo, Stanford University

3:30 PM

L1, Surface Chemistry Modifications to Contact Resistances in Organic Field-Effect Transistors: Behrang H. Hamadani¹; David A. Corley¹; Jacob W. Cizek¹; James M. Tour¹; *Douglas Natelson*¹; ¹Rice University

3:50 PM Student

L2, Chemical Doping Modified Contacts to Organic Thin Film Transistors: *Bo Bai*¹; Thomas N. Jackson¹; ¹Pennsylvania State University

4:10 PM

L3, Characterization of Top-Contact Pentacene Thin Film Transistors with Submicron-Length Channel: *Kazuhiro Tsukagoshi*¹; Kunji Shigeto¹; Fumihiro Fujimori¹; Tetzze Hamano¹; Takeo Minari¹; Iwao Yagi¹; Yoshinobu Aoyagi¹; ¹RIKEN

4:30 PM Student

L4, Electrical Contacts and Patterning Technique in n-Channel Organic Transistors: *Byungwook Yoo*¹; Taeho Jung¹; Brooks A. Jones²; Antonio Facchetti²; Tobin J. Marks²; Ananth Dodabalapur¹; ¹University of Texas at Austin; ²Northwestern University

4:50 PM

L5, Late News

Session M: Oxide Thin Film Integration I

Wednesday PM Room: Conference Room 206
June 28, 2006 Location: Pennsylvania State University

Session Chairs: Michael Lanagan, Pennsylvania State University; Darrell G. Schlom, Pennsylvania State University

1:30 PM Student

M1, Growth and Structural Characterization of TiO₂ Thin Films Deposited on SrTiO₃, LaAlO₃, and Al₂O₃ Substrates Using Reactive Molecular Beam Epitaxy: *Patrick Fisher*¹; Oleg Maksimov²; Hui Du¹; Marek Skowronski¹; Paul Salvador¹; ¹Carnegie Mellon University; ²Electro-Optics Center

1:50 PM Student

M2, Microwave Characterization of Thin Film Titanium Dioxide: *Lance Haney*¹; Michael T. Lanagan¹; Mark W. Horn¹; ¹Pennsylvania State University

2:10 PM

M3, Lattice Dynamics and Ferroelectric Phase Transitions in BaTiO₃/SrTiO₃ Superlattices Studied by Ultraviolet Raman Spectroscopy: *Dmitri A. Tenne*¹; A. Bruchhausen²; A. Fainstein²; R. S. Katiyar³; A. Cantarero⁴; A. Soukiasian¹; V. Vaithyanathan¹; W. Tian¹; D. G. Schlom¹; Y. L. Li¹; L. Q.

Chen¹; S. M. Nakhmanson⁵; K. M. Rabe⁵; C. B. Eom⁶; H. P. Sun⁷; X. Q. Pan⁷; X. X. Xi¹; ¹Pennsylvania State University; ²Centro Atómico Bariloche and Instituto Balseiro; ³University of Puerto Rico; ⁴University of Valencia; ⁵Rutgers University; ⁶University of Wisconsin; ⁷University of Michigan

2:30 PM

M4, Epitaxial Lanthanum Lutetium Oxide Thin Films Prepared by Pulsed Laser Deposition: *Juergen Schubert*¹; O. Trithaveesak¹; M. Wagner¹; T. Heeg¹; H. Y. Chen¹; C. L. Jia¹; Y. Jia²; D. G. Schlom²; ¹Forschungszentrum Jülich GmbH; ²Pennsylvania State University

2:50 PM

M5, Rare-Earth Scandate Multi-Layer Thin Films: *Tassilo Heeg*¹; Jürgen Schubert¹; Christoph Buchal¹; Markus Boese²; Martina Luysberg²; ¹Research Centre Juelich, ISG1-IT/CNI; ²Research Centre Juelich, ER-C/CNI

3:10 PM Break

3:30 PM Student

M6, Atomic Layer Deposition of Cubic Tantalum Nitride Thin Films for Gate Electrode Application: *Raghavasimhan Sreenivasan*¹; Krishna Saraswat¹; Paul McIntyre¹; ¹Stanford University

3:50 PM Student

M7, Resistive Switching Behavior in Cr-Doped SrZrO₃ Heterostructures: The Affects of Metal Electrode, Oxide Thickness, and Cr-Doping Levels: *Sukwon Choi*¹; Paul A. Salvador¹; Hwansoo Lee¹; James A. Bain¹; Jeong-Heon Park¹; Marek Skowronski¹; ¹Carnegie Mellon University

4:10 PM

M8, Comparative Investigation of Epitaxial Gd₂O₃ Thin Films Grown on Si Substrates with Different Orientations for High-K Application: *Apurba Laha*¹; Andreas Fissel²; Hans Jörg Osten¹; ¹Institute of Electronic Materials and Devices; ²Information Technology Laboratory

4:30 PM Student

M9, Epitaxial BaTiO₃/SrTiO₃ Superlattices for Phonon Bragg Mirrors and Cavities: *Arsen Soukiassian*¹; W. Tian¹; D. A. Tenne¹; X. X. Xi¹; D. G. Schlom¹; N. D. Lanzillotti Kimura²; A. Bruchhausen²; A. Fainstein²; H. P. Sun³; X. Q. Pan³; A. Cross⁴; A. Cantarero⁴; ¹Pennsylvania State University; ²Centro Atómico Bariloche and Instituto Balseiro; ³University of Michigan; ⁴University of Valencia

4:50 PM

M10, Epitaxial and Amorphous Lu₂O₃ and LaLuO₃ on Si for Alternative Gate Dielectrics Applications: *Wei Tian*¹; L. F. Edge¹; D. G. Schlom¹; V. V. Afanas'ev²; A. Stesmans²; S. Shamuilia²; B. Holländer³; J. Schubert³; ¹Pennsylvania State University; ²University of Leuven; ³Research Centre Juelich

Session N: GaN Processing

Wednesday PM Room: Conference Room 108
June 28, 2006 Location: Pennsylvania State University

Session Chair: Michael J. Manfra, Lucent Technologies

1:30 PM

N1, Substantial Advantages of Cat-CVD SiN Surface Passivation over PECVD in Electrical Properties of AlGaN/GaN Heterostructure: *Norio Onojima*¹; Masataka Higashiwaki¹; Toshiaki Matsui¹; Takashi Mimura²; ¹National Institute of Information and Communications Technology; ²Fujitsu Laboratories

1:50 PM Student

N2, Oxygen Induced Gate Leakage in AlGa_N/Ga_N HFETs and Its Suppression by a Novel Surface Control Process: *Junji Kotani*¹; Masamitsu Kaneko¹; Hideki Hasegawa¹; Tamotsu Hashizume¹; ¹Hokkaido University

2:10 PM Student

N3, SF₆/O₂ Plasma Effects on AlGa_N/Ga_N Heterojunction Field Effect Transistors: *David J. Meyer*¹; Joseph R. Flemish¹; Joan M. Redwing¹; ¹Pennsylvania State University

2:30 PM

N4, Processing of LiAlO₂ Substrates for m-Plane Ga_N Epitaxy: *Maria Losurdo*¹; Tong-Ho Kim²; Soojeong Choi²; Pae Wu²; Maria Giangregorio¹; Giovanni Bruno¹; April Brown²; ¹IMIP-CNR; ²Duke University

2:50 PM Student

N5, Matrix-Addressable III-Nitride LED Arrays on Si Substrates by Flip-Chip Technology: *Chi Wing Keung*¹; Kei May Lau¹; ¹Hong Kong University of Science and Technology

3:10 PM Break

Session O: Semiconductors: Processing and Oxidation

Wednesday PM Room: Conference Room 108
June 28, 2006 Location: Pennsylvania State University

Session Chairs: Douglas C. Hall, University of Notre Dame;
Michael A. Capano, Purdue University

3:30 PM Student

O1, The Electrical and Physical Analysis of Co_xNi_{1-x}Si₂ Gate/SiO₂/p-Si (100) with Dual Work Function for Deep Submicron Complementary Metal-Oxide-Semiconductor Device: *Jun Liu*¹; Dim Lee Kwong¹; ¹University of Texas at Austin

3:50 PM Student

O2, Studies of Surface Wetting Phenomena during Thin Film Formation by Mist Deposition: *Karthikeyan Shanmugasundaram*¹; Matt Brubaker²; Kyuhwan Chang¹; Jerzy Ruzyllo¹; ¹Pennsylvania State University; ²Symetrix Corporation

4:10 PM Student

O3, Dry Etching of PbSrSe Epitaxial Layers toward Distributed Bragg Reflectors: *An Cheng*¹; Jian Xu¹; Edward Basgall¹; Guy Lavallee¹; Michael Gerhold²; Fanghai Zhao³; Zhengping Guan³; Dewali Ray³; Zhisheng Shi³; ¹Pennsylvania State University; ²North Carolina State University; ³University of Oklahoma

4:30 PM Student

O4, A Novel Masking Technology for Deep Glass Wet Etching: *Ying-Ming Huang*¹; Maruti Uppalapati¹; William O. Hancock¹; Thomas N. Jackson¹; ¹Pennsylvania State University

4:50 PM

O5, Late News

Session P: Device Aspects for ZnO

Thursday AM Room: Deans Hall I
June 29, 2006 Location: Pennsylvania State University

Session Chairs: Julia W.P. Hsu, Sandia National Laboratories;
Jamie D. Phillips, University of Michigan

8:20 AM Student

P1, Electrical and Optical Properties of ZnO Thin Films for Transparent Electrodes and Antireflection Coatings in Optoelectronic Devices: *J. H. Yun*¹; C. H. Lim²; J. H. Lim¹; J. H. Jang¹; S. J. Park¹; ¹Gwangju Institute of Science and Technology; ²Korea Institute of Energy Research

8:40 AM

P2, Switchable Interface Charges in Zinkoxide-Bariumtitanite Heterostructures: Concepts for New Oxide-Based Electronic Device Structures: *Mathias M. Schubert*¹; Nurdin Ashkenov²; Rao Voora²; Holger Hochmuth²; Michael Lorenz²; Marius Grundmann²; ¹University of Nebraska-Lincoln; ²University Leipzig

9:00 AM Student

P3, Metal-Ferroelectric-Semiconductor Capacitors Based on PZT/ZnO Heterostructures: *Emine Cagin*¹; Ding-Yuan Chen¹; Jeffrey Siddiqui¹; Jamie D. Phillips¹; ¹University of Michigan

9:20 AM Student

P4, ZnO Schottky Diode Performance as a Function of Contact Metal and Surface Polarity: *Martin W. Allen*¹; W. C. T. Lee¹; P. Miller¹; R. J. Reeves¹; M. M. Alkaisi¹; S. M. Durbin¹; ¹University of Canterbury

9:40 AM Student

P5, Zinc Oxide Thin Films Deposited by Reactive RF Sputtering for Metal-Semiconductor-Metal Photodectors and Solar Cells: *Meiya Li*¹; Nehal Chokshi²; Robert L. DeLeon²; Gary Tompa²; Wayne A. Anderson¹; ¹State University of New York at Buffalo; ²AMBP Tech Corporation

10:00 AM Break

10:20 AM

P6, Hybrid II-VI and III-V Compound Double Heterostructures and Their Properties: *Yahya Alivov*¹; ¹Virginia Commonwealth University

10:40 AM Student

P7, Investigation of ZnO Dry Etching in Inductively Coupled CH₄/H₂- and C₂H₆/H₂-Based Plasmas: *Wantae Lim*¹; Lars Voss¹; Rohit Khanna¹; Brent P. Gila¹; David P. Norton¹; Stephen J. Pearton¹; Fan Ren¹; ¹University of Florida

11:00 AM Student

P8, Magnetic Properties and Observation of Anomalous Hall Effect in Cobalt-Doped ZnO: *Mathew Ivill*¹; Ryan Pate¹; David P. Norton¹; Arthur F. Hebard¹; Ritesh Das¹; ¹University of Florida

11:20 AM Student

P9, Growth and Physical Properties of N-Al or Cu Co-Doped (Zn,Co)O Dilute Magnetic Semiconductors: *Govind Mundada*¹; Craig J. Vera¹; Damon E. Horst¹; Theodore W. Kehl¹; Srikanth Manchiraju¹; Sandhya Pulugam¹; Pawan K. Kahol¹; Manivannan Kandiah¹; Kartik Ghosh¹; ¹Missouri State University

11:40 AM

P10, Optical and Magnetic Properties of ZnV_o Prepared by Ion Implantation: *Vitaliy Avrutin*¹; Umit Ozgur¹; Sergey Chevtchenko¹; Hadis Morkoc¹; Michael Callahan²; ¹Virginia Commonwealth University; ²Air Force Research Laboratory

Session Q: III-Nitride MOCVD Growth

Thursday AM
June 29, 2006

Room: Deans Hall II
Location: Pennsylvania State University

Session Chairs: Andrew Allerman, Sandia National Laboratories;
Jae-Hyun Ryou, Georgia Institute of Technology

8:20 AM

Q1, Pulsed Lateral over Growth (PLOG) of Al_xGa_{1-x}N: M. Asif Khan¹; *Qhalid Fareed*²; Chen Zheng¹; Mickael Gaevski¹; Vinod Adivarahan¹; Jinwei Yang¹; ¹University of South Carolina; ²Sensor Electronic Technology Inc.

8:40 AM Student

Q2, MOCVD Growth of Nonpolar M-Plane AlN on (1-100) 6H-SiC Substrate: *Qian Sun*¹; Zaiyuan Ren¹; Soon-Yong Kwon¹; Jung Han¹; ¹Yale University

9:00 AM

Q3, Halide Chemical Vapor Deposition of AlN: *Timothy E. Bogart*¹; Mark Fanton¹; Xiaojun Weng²; Ed Oslosky¹; Brian Weiland¹; Rodney Ray¹; Adam Dilts¹; David Snyder¹; ¹Pennsylvania State Electro-Optics Center; ²Pennsylvania State University

9:20 AM

Q4, Extremely High Quality AlN Grown on (0001) Sapphire by Using Metal-Organic Vapor Phase Epitaxy: *Yangang A. Xi*¹; Kaixuan Chen¹; Frank W. Mont¹; Xiaolu Li¹; Jong Kyu Kim¹; E. Fred Schubert¹; Wayne Liu²; Joseph A. Smart²; ¹Rensselaer Polytechnic Institute; ²Crystal IS

9:40 AM

Q5, Late News

10:00 AM Break

10:20 AM

Q6, Effects of Compositionally Graded Al_{1-x}Ga_xN Buffer Layers on the Threading Dislocation Evolution in GaN Films Grown on (111) Si Substrates: *Xiaojun Weng*¹; Srinivasan Raghavan¹; Abhishek Jain¹; Jeremy Acord¹; Elizabeth Dickey¹; Joan Redwing¹; ¹Pennsylvania State University

10:40 AM Student

Q7, Crack Free GaN Grown on Patterned Si(111) Substrates by Metal-Organic Chemical Vapor Deposition: *Hu Liang*¹; Baoshun Zhang¹; Kar Wei Ng¹; Chi Wing Keung¹; Kei May Lau¹; ¹Photonics Technology Center

11:00 AM Student

Q8, Defect Reduction in Nonpolar A-Plane GaN Films Using In-Situ SiN_x Nano-Mask: *Kwang-Choong Kim*¹; Arpan Chakraborty¹; Feng Wu¹; James S. Speck¹; Umesh K. Mishra¹; Steven DenBaars¹; ¹University of California, Santa Barbara

11:20 AM

Q9, Maskless Epitaxial Lateral Overgrowth of GaN Using Dimethylhydrazine as a Nitrogen Precursor: *Toshiyuki Takizawa*¹; Jun Shimizu¹; Tetsuzo Ueda¹; ¹Matsushita Electric Industrial, Company, Ltd.

11:40 AM

Q10, Room Temperature Layer-by-Layer Epitaxial Growth of GaN

Session R: Lattice Engineered Epitaxy of III-V and IV Semiconductors

Thursday AM Room: Conference Room 106
June 29, 2006 Location: Pennsylvania State University

Session Chairs: Sarah Olsen, University of Newcastle-upon-Tyne;
Jerry M. Woodall, Purdue University

8:20 AM Student

R1, Materials Optimization for High Indium Content (In,Ga)As Channel HEMTs: *Mike Morse*¹; ¹Duke University

8:40 AM Student

R2, High-Mobility 2DEG in InAlAs/InAs Heterostructures Grown on InP Using Metamorphic InAs_yP_{1-y} Graded Buffers: *Yong Lin*¹; Aaron R. Arehart¹; Andrew M. Carlin¹; John A. Carlin¹; Steven A. Ringel¹; ¹Ohio State University

9:00 AM Student

R3, High-Quality InP on GaAs Using Graded Buffers Grown by MOVPE (Metal Organic Vapor Phase Epitaxy): *Nate Quitoriano*¹; Eugene A. Fitzgerald¹; ¹Massachusetts Institute of Technology

9:20 AM

R4, Optical and Electrical Defect Characterization of In_{0.49}Ga_{0.51}P Grown on Metamorphic SiGe Substrates: *Maria Gonzalez*¹; Andrew Armstrong¹; Carrie Andre²; Steven Ringel¹; Arthur Pitera³; Eugene Fitzgerald⁴; ¹Ohio State University; ²Akzo Nobel; ³Contour Semiconductor; ⁴Massachusetts Institute of Technology

9:40 AM Student

R5, Lattice-Engineering for Monolithic Visible Yellow-Green Light Emitters: *Michael J. Mori*¹; Eugene A. Fitzgerald¹; ¹Massachusetts Institute of Technology

10:00 AM Break

10:20 AM Student

R6, The Fabrication of Misfit Dislocation-Free Strained Si Thin Films Using Porous Si Substrates: *Jeehwan Kim*¹; Ya-hong Xie¹; ¹University of California at Los Angeles

10:40 AM

R7, Novel Fabrication Process for Multi SOI Layers Using Selective Etching of SiGe in Multi Si/SiGe Layers: *Shun-Ichiro Ohmi*¹; Tomoyuki Nakanishi¹; Ken-Ichi Yahashi¹; Tetsushi Sakai¹; ¹Tokyo Institute of Technology

11:00 AM

R8, Perimeter-Limited Strain in Patterned Structures of SSOI: *Albert J. Paul*¹; ¹National Institute of Standards and Technology

11:20 AM

R9, FET Mobilities in Layers Grown by Ultra-High Growth Rate CVD with High-Order Silane Precursor: *Keith H. Chung*¹; J. C. Sturm¹; K. K. Singh²; D. Carlson²; S. Kuppurao²; ¹Princeton University; ²Applied Materials

11:40 AM

R10, Late News

Session S: SiC: Growth and Interface Studies

Thursday AM Room: Conference Room 208
June 29, 2006 Location: Pennsylvania State University

Session Chair: Michael A. Capano, Purdue University

8:20 AM

S1, Effects of Hydrogen on Physical Vapor Transport Growth and Deep Trap Concentrations in 6H SiC: *Mark Fanton*¹; Marek Skowronski²; Alexander Polyakov²; Randal Cavalero¹; Rodney Ray¹; ¹Pennsylvania State University; ²Carnegie Mellon University

8:40 AM Student

S2, Surface Morphology, Doping and Oxide Field of 4H-SiC C-Face Epitaxial Layer Grown by Horizontal Hot-Wall Chemical Vapor Deposition: *Kung-Yen Lee*¹; Wenzhou Chen¹; Michael A. Capano¹; ¹Purdue University

9:00 AM

S3, Chemical Vapor Deposition of Silicon Carbide Epitaxial Films and Their Characterization: Yi Chen¹; *Govindhan Dhanaraj*¹; Hui Chen¹; William Vetter¹; Hui Zhang¹; Michael Dudley¹; ¹Stony Brook University

9:20 AM

S4, Formation Mechanism of Half-Loop Array Defect in Silicon Carbide Homo-Epilayers: *Zehong Zhang*¹; Robert Stahlbush²; Pirouz Pirouz³; Amitesh Shrivastava¹; Tangali Sudarshan¹; ¹University of South Carolina; ²Naval Research Laboratory; ³Case Western Reserve University

9:40 AM

S5, Structural and Electrical Characterization of Carbon Nanotubes Formed on Silicon Carbide Materials by Surface Decomposition: *John Boeckl*¹; William C. Mitchell¹; Bill Riehl²; Mike Check²; ¹Air Force Research Laboratory; ²Riehl-Check Industries

10:00 AM Break

10:20 AM

S6, Role of Interface Layers and Localized States in TiAl-Based Ohmic Contacts to P-Type 4H-SiC: *Min Gao*¹; Sergey Tumakha¹; Stefen Goss¹; T. Onishi²; Susumu Tsukimoto²; Masanori Murakami²; Leonard Brillson²; ¹Ohio State University; ²Kyoto University

10:40 AM

S7, As-Deposited Ohmic Contacts Using Ti on InN on SiC: Feroz A. Mohammad¹; Yan Cao¹; *Lisa M. Porter*¹; Ariel Virshup¹; ¹Carnegie Mellon University

11:00 AM Student

S8, Electronic States of Chemically Treated and/or Oxidized SiC Surfaces: *Shu Nie*¹; R. M. Feenstra¹; Y. Ke²; R. P. Devaty²; W. J. Choyke²; ¹Carnegie Mellon University; ²University of Pittsburgh

11:20 AM Student

S9, Effect of Oxide Deposition Temperature on Interface Properties of SiC/SiO₂: *Tahir A. Khan*¹; Mahalingam K. Balasubramanian¹; T. P. Chow¹; ¹Rensselaer Polytechnic Institute

11:40 AM

S10, Late News

Session T: Materials and Processing for Organic Transistors

Thursday AM Room: Conference Room 207
June 29, 2006 Location: Pennsylvania State University

Session Chair: Alberto Salleo, Stanford University; Jon Nichols, 3M Center

8:20 AM Invited

T1, Solution-Processable Organic Conductors and Semiconductors: Viable Materials for Thin Film Electronics: *Lynn Loo*¹; ¹University of Texas

9:00 AM

T2, Acene-Based Materials for Thin-Film Transistors: *John E. Anthony*¹; ¹University of Kentucky

9:20 AM Student

T3, Pentacene Devices Fabricated by Organic Vapor Phase Deposition: *Cédric Rolin*¹; Soeren Stuedel¹; Kris Myny¹; David Cheyns¹; Stijn Verlaak¹; Jan Genoe¹; Paul Heremans¹; ¹IMEC

9:40 AM Student

T4, Molecular Ordering of Solution Processed TIPS-Pentacene: *Sungkyu Park*¹; Thomas N. Jackson¹; John E. Anthony²; ¹Pennsylvania State University; ²University of Kentucky

10:00 AM Break

10:20 AM Student

T5, Zinc Tetrabenzoporphyrin Organic Field-Effect Transistors: *Patrick Shea*¹; Jerzy Kanicki¹; Hiroko Yamada²; Noboru Ono²; ¹University of Michigan; ²Ehime University

10:40 AM Student

T6, Modeling and Experiments of Organic Material Patterning by Stamping in the Fabrication of Organic Electronic Devices: *Yifang Cao*¹; Changsoon Kim¹; Stephen R. Forrest¹; Winston O. Soboyejo¹; ¹Princeton University

11:00 AM Student

T7, Pentacene OTFTs with Parylene Active Layer Patterning and Passivation: Lisong Zhou¹; *Dalong Zhao*¹; Thomas N. Jackson¹; ¹Pennsylvania State University

11:20 AM

T8, All Organic Non-Volatile Switching Device Fabricated by Using Conducting Polymer Micropores: *Oleg Kirillov*¹; John S. Suehle¹; Lauren Cohen²; Wendy Wu³; Dean M. DeLongchamp¹; Curt A. Richter¹; ¹National Institute of Standards and Technology; ²Duke University; ³University of Texas at Austin

11:40 AM

T9, Late News

Session U: Oxide Thin Film Integration II

Thursday AM
June 29, 2006

Room: Conference Room 206
Location: Pennsylvania State University

Session Chairs: Patrick Lenahan, Pennsylvania State University;
Michael Lanagan, Pennsylvania State University

8:20 AM

U1, Photocurrent-Voltage Measurements for Characterizing Oxide Charge in HfO₂ Gate Dielectrics: *Daniel Felnhofer*¹; Evgeni Gousev¹; Douglas A. Buchanan²; ¹Qualcomm MEMS Technologies; ²University of Manitoba

8:40 AM

U2, Internal Photoemission Studies of TaSiN and TaCN Metal Gates on SiO₂ and HfO₂: *Nhan V. Nguyen*¹; H. Xiong¹; J. S. Suehle¹; E. M. Vogel¹; ¹National Institute of Standards and Technology

9:00 AM Student

U3, Electron Spin Resonance and Spin Dependent Recombination Study of Deep Levels within the near Si/Dielectric Interfacial Layer of HfO₂ Based Metal Oxide Silicon Field Effect Transistors: *Jason T. Ryan*¹; Patrick Lenahan¹; Jason Campbell¹; Gennadi Bersuker²; Patrick Lysaght²; Wilman Tsai³; ¹Pennsylvania State University; ²SEMATECH; ³Intel

9:20 AM

U4, Photoemission and Inverse Photoemission Studies of Band Offsets in Alternative High-k Metal Oxide Semiconductor (MOS) Stacks: *Eric Bersch*¹; Sylvie Rangan¹; Robert Bartynski¹; Eric Garfunkel¹; ¹Rutgers University

9:40 AM

U5, Growth and Characterization of Epitaxial Sc₂O₃ on Silicon by Molecular Beam Epitaxy for Alternative Gate Dielectric Applications: Lisa Friedman Edge¹; Wei Tian¹; Venu Vaithyanathan¹; *Darrell G. Schlom*¹; Dmitri Klenov²; Susanne Stemmer²; Marilyn E. Hawley³; ¹Pennsylvania State University; ²University of California, Santa Barbara; ³Los Alamos National Laboratory

10:00 AM Break

10:20 AM

U6, Medium Energy Ion Scattering Study of Oxygen Diffusion-Reactions in High-k Dielectrics on Si: *Lyudmila Goncharova*¹; Mateus Dalponte¹; Eric Garfunkel¹; Torgny Gustafsson¹; Patrick Lysaght²; Brendan Foran²; Gennadi Bersuker²; ¹Rutgers University; ²Sematech

10:40 AM

U7, In_{0.13}Ga_{0.87}As and GaAs MOS Capacitors with ALD HfO₂ and Al₂O₃ Gate Dielectrics: *N. Goel*¹; C. Chui¹; P. Majhi¹; D. Choi²; J. Harris²; W. Tsai¹; ¹Intel; ²Stanford University

11:00 AM Student

U8, Characterization of n-MISFETs with Ultrathin HfO_xN_y Gate Insulator Formed by ECR-Ar/N₂ Plasma Nitridation: *Masaki Satoh*¹; Tomoki Kurose¹; Shun-Ichiro Ohmi¹; ¹Tokyo Institute of Technology

11:20 AM

U9, Late News

11:40 AM

U10, Late News

Session V: Non-Destructive Testing and In-Situ Monitoring and Control

Thursday AM Room: Conference Room 108
June 29, 2006 Location: Pennsylvania State University

Session Chairs: Andrew M. Hoff, University of South Florida; Kurt G. Eyink, Air Force Research Laboratory

8:20 AM Student

V1, Surface Plasmon Resonance of Ga and In Nanoparticles Measured by In-Situ Spectroscopic Ellipsometry: *Pae C. Wu*¹; Maria Losurdo²; Tong-Ho Kim¹; Soojeong Choi¹; Henry Everitt¹; Jianhua Jiang³; April S. Brown¹; ¹Duke University; ²Institute of Inorganic Methodologies and of Plasmas — CNR; ³University of Alabama, Huntsville

8:40 AM Student

V2, Kinetics of Ga Adlayer Formation on Gallium Nitride (0001) Surface: *Soojeong Choi*¹; Tong-Ho Kim¹; Henry O. Everitt¹; April Brown¹; Maria Losurdo²; Giovanni Bruno²; Akihiro Moto³; ¹Duke University; ²IMIP-CNR; ³Innovation Core SEI, Inc

9:00 AM Student

V3, Spectroscopic Ellipsometric Characterization of Metal-Free Carbon Nanotube Formation by SiC Surface Decomposition: *Jeremy Harrison*¹; Senthil N. Sambandam¹; John J. Boeckl²; William C. Mitchel²; Warren E. Collins¹; Weijie Lu¹; ¹Fisk University; ²Air Force Research Laboratory

9:20 AM

V4, Reduced Interference Photoreflectance for Measurement of HBTs: *Eric Rehder*¹; Peter Rice¹; ¹Kopin Corporation

9:40 AM Student

V5, AlGaAs/GaAs Interface States by Surface Photovoltage Studies: *Clara Vargas*¹; Gregory B. Lush¹; ¹University of Texas at El Paso

10:00 AM Break

10:20 AM

V6, Quantification of Ultra-Thin Indium MBE Layers by Low Energy X-Ray Emission Spectroscopy (LEXES): *Kurt G. Eyink*¹; Jeremy J. Pitzl¹; David H. Tomich¹; John A. Carlin²; Krishnamurthy Mahalingam³; Howard E. Smith⁴; C. A. Hitzman⁵; C. A. Evans⁵; ¹Air Force Research Laboratory; ²Ohio State University; ³Universal Technology Corporation; ⁴University of Dayton; ⁵Full Wafer Analysis Inc

10:40 AM Student

V7, In-Situ Investigation of Surface Stoichiometry during YMnO₃, InGaN and GaN Growth by Plasma-Assisted Molecular Beam Epitaxy Using RHEED-TRAXS: *Randy P. Tompkins*¹; Eric D. Schires¹; Kyoungnae Lee¹; Yewhee Chye¹; David Lederman¹; Thomas H. Myers¹; ¹West Virginia University

11:00 AM

V8, Composition Driven Surface Transition and Electronic Transport in LaSrMnO₃: *Maitri P. Warusawithana*¹; Xiaofang Zhai²; Seongshik Oh³; Darrell G. Schlom⁴; James N. Eckstein²; ¹Department of Physics, University of Illinois at Urbana-Champaign; Department of Materials Science and Engineering, Pennsylvania State University; ²Department of Physics, University of Illinois at Urbana-Champaign; ³Department of Physics, University of Illinois at Urbana-Champaign; National Institute of Standards and Technology, Boulder; ⁴Department of Materials Science and Engineering, Pennsylvania State University

11:20 AM Student

V9, Structural Transformations Underlying the Refractive Index Contrast for Optical Waveguides in He-Implanted Single Crystal PZN-PT: N. Tangtrakarn¹; J. Dziedzic¹; S. Hackney¹; *Peter Moran*¹; ¹Michigan Technological University

11:40 AM Student

V10, Pre-Oxidation Iron Contamination of Silicon and 4H-SiC Substrates: *Helen Benjamin*¹; Elena Oborina¹; Andrew M. Hoff¹; ¹University of South Florida

Session W: ZnO Growth

Thursday PM
June 29, 2006

Room: Deans Hall I
Location: Pennsylvania State University

Session Chairs: Jamie D. Phillips, University of Michigan; Julia W.P. Hsu, Sandia National Laboratories

1:30 PM Student

W1, Zinc Oxide Thin Films Deposited by Laser Assisted Molecular Beam Deposition: *Meiya Li*¹; Nehal Chokshi²; Robert L. DeLeon²; Gary Tompa²; Wayne A. Anderson¹; ¹State University of New York at Buffalo; ²AMBP Tech Corporation

1:50 PM Student

W2, The Effect of Substrate Material and Post-Annealing on DC Sputtered ZnO: *Leo P. Schuler*¹; Paul Miller¹; Martin Allen¹; Nagarajan Valanoor¹; Roger Reeves¹; Maan Alkaisi¹; ¹MacDiarmid Institute

2:10 PM

W3, Effect of Substrate Surface Structure and Chemistry on Microstructure and Properties of Epitaxial ZnO Thin Films Grown on Sapphire and ZnO Substrates: *Xiaoqing Pan*¹; Haiping Sun¹; Yanbin Chen¹; Xinqiang Wang²; Akihiko Yoshikawa²; ¹University of Michigan; ²Chiba University

2:30 PM

W4, Plasma-Assisted MOCVD Growth of Highly Oriented ZnO Thin Films: *Maria Losurdo*¹; Maria M. Giangregorio¹; Pio Capezzuto¹; Giovanni Bruno¹; Graziella Malandrino²; Ignazio Fragala²; ¹IMIP-CNR; ²Universita di Catania

2:50 PM Student

W5, Surface and Interface Characterization of A-Plane ZnO and Mg_xZn_{1-x}O Films: *Gaurav Saraf*¹; Jian Zhong¹; Yicheng Lu¹; Olga Dulub²; Ulrike Diebold²; Theo Siegrist³; ¹Rutgers University; ²Tulane University; ³Bell Laboratories

3:10 PM Break

3:30 PM

W6, Three Step Growth as a Novel Approach for the Growth of ZnO on Si(111) by MOVPE: *Takumi Moriyama*¹; Shizuo Fujita¹; ¹Kyoto University

3:50 PM Student

W7, Growth of ZnO on Cubic Substrates by Molecular Beam Epitaxy: *Emine Cagin*¹; Jun Yang¹; Jamie D. Phillips¹; Pallab Bhattacharya¹; ¹University of Michigan

4:10 PM Student

W8, ZnO Thin Films Produced via Reactive Pulsed Arc Molecular Beam Deposition: *Chi-Tung Chiang*¹; Robert L. DeLeon²; James F. Garvey¹; ¹University at Buffalo; ²AMBP Tech Corporation

4:30 PM Student

W9, Low Temperature Highly Conducting Boron-Doped ZnO Films by Plasma Enhanced Chemical Vapor Deposition: *Jie Sun*¹; Diwakar Garg²; Thomas N. Jackson¹; ¹Pennsylvania State University; ²Air Products and Chemicals, Inc

4:50 PM

W10, Late News

Session X: MBE Growth of Group III-Nitrides

Thursday PM

Room: Deans Hall II

June 29, 2006

Location: Pennsylvania State University

Session Chairs: Thomas Myers, West Virginia University; Steven M. Durbin, University of Canterbury

1:30 PM

X1, Optical Investigation of the Dependence of Luminescence Efficiency on Stokes Shift in Nanoscale Compositionally Inhomogeneous AlGaN: *Gregory A. Garrett*¹; Anand V. Sampath¹; H. Shen¹; Michael Wraback¹; ¹U.S. Army Research Laboratory

1:50 PM Student

X2, The Use of Cathodoluminescence in Gallium Nitride during Growth to Determine Substrate Temperature: *Kyoungnae Lee*¹; Eric D. Schires¹; Thomas H. Myers¹; ¹West Virginia University

2:10 PM Student

X3, A New Mechanism for the Tilting of Dislocations in Oxygen Doped Gallium Nitride Layers Grown by Molecular Beam Epitaxy: *Michael E. Hawkrige*¹; David Cherns¹; Kyoung-Nae Lee²; Tom Myers²; ¹University of Bristol; ²West Virginia University

2:30 PM

X4, Unintentional Si Incorporation in GaN/AlN Interface Grown on SiC by PAMBE: *Tong-Ho Kim*¹; Soojeong Choi¹; Pae Wu¹; Changyun Yi¹; April Brown¹; Maria Losurdo²; Giovanni Bruno²; Akihiro Moto³; ¹Duke University; ²IMIP-CNR; ³Innovation Core SEI, Inc.

2:50 PM

X5, High-Quality Nonpolar 4H-AlN Grown on 4H-SiC by Molecular-Beam Epitaxy: *Masahiro Horita*¹; Jun Suda¹; Tsunenobu Kimoto¹; ¹Kyoto University

3:10 PM Break

3:30 PM Student

X6, Physical Processes during Growth of InN on GaN (0001) by Plasma-Assisted Molecular Beam Epitaxy: *Emmanouil Dimakis*¹; Eleftherios Iliopoulos¹; Alexandros Georgakilas¹; ¹Microelectronics Research Group, University of Crete/Institute of Electronic Structure and Laser (IESL), Foundation for Research and Technology-Hellas (FORTH)

3:50 PM

X7, Study of PA-MBE Growth of In- and N-Polar InN on SiC Substrates: *Maria Losurdo*¹; Maria Giangregorio¹; Giovanni Bruno¹; Tong-Ho Kim²; Soojeong Choi²; Pae Wu²; April Brown²; ¹IMIP-CNR; ²Duke University

4:10 PM Student

X8, Direct Write Composition Patterning of InGaN during Molecular Beam Epitaxy: *Xiaodong Chen*¹; William J. Schaff¹; ¹Cornell University

4:30 PM

X9, Growth of In-Rich $\text{In}_x\text{Al}_{1-x}\text{N}$ Films on (0001) Sapphire by RF-MBE and Their Properties: *Hiroyuki Naoi*¹; Keisuke Fujiwara¹; Masahito Kurouchi¹; Daisuke Muto¹; Tsutomu Araki¹; Hyunseok Na¹; Yasushi Nanishi¹; ¹Ritsumeikan University

4:50 PM Student

X10, Structural, Optical and Electronic Properties of InN Grown on GaN Substrate by Molecular Beam Epitaxy: *Kejia (Albert) Wang*¹; John Simon¹; Jing Zhang¹; Kai Sun¹; Tom Kosel¹; Alexander Mintairov¹; James Merz¹; Debdeep Jena¹; ¹University of Notre Dame

Session Y: Epitaxy for Devices

Thursday PM
June 29, 2006

Room: Conference Room 106
Location: Pennsylvania State University

Session Chairs: Michael Tischler, Ocis Technology; Archie L. Holmes, University of Texas

1:30 PM

Y1, Selective MBE Growth of Hexagonal Networks of GaAs Triangular Nanowires on (111)B Patterned Substrates: Isao Tamai¹; Takahiro Tamura¹; Taketomo Sato¹; *Hideki Hasegawa*¹; Tamotsu Hashizume¹; ¹Hokkaido University

1:50 PM Student

Y2, Structural and Electronic Characterization of Homoepitaxial SrTiO_3 Films Prepared by Molecular Beam Epitaxy: *Charles M. Brooks*¹; Wei Tian¹; Darrell G. Schlom¹; Shawn Walsh²; Leonard Brillson²; Tassilo Heeg³; Jürgen Schubert³; ¹Pennsylvania State University; ²Ohio State University; ³Forschungszentrum Jülich GmbH

2:10 PM Student

Y3, Asymmetric Relaxation of Semiconductor Grade SrTiO_3 Films: *Michael D. Biegalski*¹; Dillon Fong²; Yulan Li¹; Jeffery Haeni¹; Long Qing Chen¹; Reinhert Uecker³; Paul Reiche³; Jeffery Eastman²; Paul Fuoss²; Stephen Streiffer²; Susan Trolrier-McKinstry¹; Darrell Schlom¹; ¹Pennsylvania State University; ²Argonne National Laboratory; ³Institute of Crystal Growth, Berlin

2:30 PM Student

Y4, Structural and Magnetic Properties of MBE Grown Single Crystal Co_2MnGe on $\text{SrTiO}_3(001)$, $\text{BaTiO}_3(001)$ and $\text{MgO}(001)$ Substrates: *Swadesh Kumar Srivastava*¹; Christoph Adelman¹; Darrell Schlom²; Charles Ahn³; Christopher Palmstrom¹; ¹University of Minnesota; ²Pennsylvania State University; ³Yale University

2:50 PM Student

Y5, Fabrication and Optical Modulation of Silicon-Filled Capillary Fiber: *Dong-Jin Won*¹; Hoonsoo Kang¹; Neil Baril²; Adrian Amezcua-Correa³; Chris. E. Finlayson³; Pier J.A. Sazio³; Venkatraman Gopalan¹; John V. Badding²; ¹Materials Research Institute, Pennsylvania State University; ²Department of Chemistry, Pennsylvania State University; ³Optoelectronics Research Centre, University of Southampton

3:10 PM Break

3:30 PM Student

Y6, MBE-Grown $\text{Zn}_x\text{Cd}_{(1-x)}\text{Se}/\text{Zn}_x\text{Cd}_y\text{Mg}_{(1-x-y)}\text{Se}$ Multi-Quantum Wells for Intersubband Devices: *Hong Lu*¹; A. Shen²; S. K. Zhang²; R. R. Alfano²; C. Y. Song³; H. C. Liu³; M. C. Tamargo²; ¹City College of New York and Graduate Center of CUNY; ²City College of New York; ³Institute for

3:50 PM Student

Y7, Effectiveness of SiGe Buffer Layers in Reducing Dark Current in Ge-on-Si Photodetectors: *Zhihong Huang*¹; Ning Kong¹; Jungwoo Oh²; Sanjay K. Banerjee¹; Joe C. Campbell³; ¹University of Texas at Austin; ²Sematech; ³University of Virginia

4:10 PM Student

Y8, Accurate Carbon Doping System for Low-Voltage and Low-Loss VCSELS: *Yu-Chia Chang*¹; Chad S. Wang¹; John E. English²; Larry A. Coldren¹; ¹ECE Department, University of California, Santa Barbara; ²Materials Department, University of California, Santa Barbara

4:30 PM Student

Y9, Optically Pumped GaSb Based “Arsenic Free” Mid IR Vertical Cavity Surface Emitting Laser Design: *Ravi Kalyanam*¹; Abdenour Amtout¹; Ralph Dawson¹; Phil Dowd¹; Sanjay Krishna¹; ¹Center for High Technology Materials

4:50 PM Student

Y10, Monolithic GaSb-Based VCSEL on Si: *Ganesh Balakrishnan*¹; Shenghong Huang¹; Anitha Jallipalli¹; Arezou Khoshakhlagh¹; Manish Mehta¹; Paul Rotella¹; L. R. Dawson¹; Sanjay Krishna¹; D. L. Huffaker¹; ¹University of New Mexico

Session Z: SiC: Characterization

Thursday PM
June 29, 2006

Room: Conference Room 208
Location: Pennsylvania State University

Session Chairs: Robert S. Okojie, NASA Glenn Research Center;
Robert Stahlbush, Naval Research Laboratory

1:30 PM

Z1, Optical Characterization of Stacking Faults in 4H-SiC PiN Diodes: *Joshua D. Caldwell*¹; Paul B. Klein¹; Robert E. Stahlbush¹; Orest J. Glembocki¹; Kendrick X. Liu¹; Karl D. Hobart¹; Fritz Kub¹; ¹Naval Research Laboratory

1:50 PM

Z2, A 180 A/4.5 kV 4H-SiC PiN Diode for High Current Power Modules: *Brett A. Hull*¹; Mrinal K. Das¹; James T. Richmond¹; Joseph J. Sumakeris¹; Robert Leonard¹; John W. Palmour¹; Scott Leslie²; ¹Cree, Inc.; ²Powerex, Inc.

2:10 PM

Z3, Improvement of PMOS Channel Properties for 4H-SiC P-IGBTs: *Mrinal K. Das*¹; Sarah K. Haney¹; Sei-Hyung Ryu¹; Qingchun Zhang¹; ¹Cree, Inc.

2:30 PM

Z4, Photo and Electro Luminescence Imaging of Carrot Defect in 4H-SiC Epitaxy: *Kendrick X. Liu*¹; Robert E. Stahlbush¹; Joshua D. Caldwell¹; Karl D. Hobart¹; Francis J. Kub¹; Evan R. Glaser¹; ¹US Naval Research Laboratory

2:50 PM

Z5, Identification of a Three-Site Defect in SI 4H-SiC: *Nelson Y. Garces*¹; William E. Carlos¹; Evan R. Glaser¹; Mark A. Fanton²; ¹Naval Research Laboratory; ²Electro-Optics Center

3:10 PM Break

3:30 PM

Z6, EPR Characterization of Halide CVD 4H SiC: *Mary Ellen Zvanut*¹; H. J. Chung²; A. Y. Polyakov²; ¹University of Alabama at Birmingham; ²Carnegie Mellon University

3:50 PM

Z7, Effect of Electron-Irradiation on Deep Centers in High-Purity Semi-Insulating 6H-SiC: *Zhaoqiang Fang*¹; Gary C. Farlow¹; Bruce Clafin¹; David C. Look¹; ¹Wright State University

4:10 PM Student

Z8, Deep Level Defects which Limit Current Gain in 4H SiC Bipolar Junction Transistors: *Corey Cochrane*¹; Patrick Lenahan¹; Aivars Lelis²; ¹Pennsylvania State University; ²Army Research Laboratories

4:30 PM

Z9, Performance of SiC Field-Effect Devices at Elevated Temperature during Several Months of Continuous Operation: *Ruby N. Ghosh*¹; Reza Loloee¹; ¹Michigan State University

4:50 PM

Z10, Late News

Session AA: Organic/Inorganic Hybrid Photovoltaics

Thursday PM
June 29, 2006

Room: Conference Room 207
Location: Pennsylvania State University

Session Chairs: Max Shtein, University of Michigan; David J. Gundlach, National Institute of Standards and Technology

1:30 PM Invited

AA1, Metal Nanostructure Enhanced Organic Solar Cells: *Peter Peumans*¹; ¹Stanford University

2:10 PM Student

AA2, Organic Photovoltaic Cells with External Antennas: *Jonathan K. Mape*¹; Timothy D. Heidel¹; Celebi Kemal¹; Marc A. Baldo¹; ¹Massachusetts Institute of Technology

2:30 PM Student

AA3, A Quantum Dot Photovoltaic Device Fabricated via Microcontact Printing: *Alexi Arango*¹; David Oertel²; Mounji Bawendi²; Vladimir Bulovic¹; ¹Massachusetts Institute of Technology, Department of Electrical Engineering; ²Massachusetts Institute of Technology, Department of Chemistry

2:50 PM

AA4, Late News

3:10 PM Break

3:30 PM

AA5, Transparent Conducting SWNT Electrodes for Plastic Solar Cells: *Aurelien Du Pasquier*¹; Husnu Emrah Unalan¹; Alokik Kanwal¹; Steve Miller¹; Manish Chhowalla¹; ¹Rutgers University

3:50 PM Student

AA6, Hybrid Conjugated Polymer/Nanostructured ZnO Photovoltaic Devices: *Dana C. Olson*¹; Sean E. Shaheen¹; Matthew S. White¹; Reuben T. Collins²; David S. Ginley¹; ¹National Renewable Energy Laboratory (NREL); ²Colorado School of Mines

4:10 PM Student

AA7, Nanostructured Hybrid Solar Cells: *Vignesh Gowrishankar*¹; Shawn R. Scully¹; Albert T. Chan¹; Michael D. McGehee¹; ¹Stanford University

4:30 PM Student

AA8, Investigating Charge Dynamics of Small Molecule Organic Heterojunction Interfaces in Lateral Photoconductor Devices: *John Ho*¹; Vladimir Bulovic¹; ¹Massachusetts Institute of Technology

4:50 PM

AA9, Late News

Session BB: Oxide Thin Film Integration III

Thursday PM
June 29, 2006

Room: Conference Room 206
Location: Pennsylvania State University

Session Chairs: Darrell Schlom, Pennsylvania State University;
Patrick Lenahan, Pennsylvania State University

1:30 PM

BB1, Electrical Evaluation of MBE-Grown Lanthanum Aluminate Dielectric on Ge Channels: *Chi On Chui*¹; Wilman Tsai¹; Lisa Edge²; Maitri Warusawithana²; Darrell Schlom²; ¹Intel Corporation; ²Pennsylvania State University

1:50 PM Student

BB2, GaN MOSFET with ALD High-k Gate Dielectric: *Yanqing Wu*¹; Peide (Peter) Ye¹; Glen Wilk²; ¹Purdue University; ²ASM America

2:10 PM Student

BB3, CV Studies on ALD Al₂O₃/GaAs and Al₂O₃/InGaAs Interfaces for Enhancement-Mode GaAs MOSFET Application: *H. C. Lin*¹; Yi Xuan¹; Peide (Peter) Ye¹; Glen Wilk²; ¹Purdue University; ²ASM America

2:30 PM Student

BB4, GaAs Growth on Silicon Substrates Using a Thin (~80 Nm) Si_xGe_{1-x} Step-Graded Buffer Layer for High-k III-V MOSFET Applications: *Michael M. Oye*¹; Davood Shahrjerdi¹; Xiaojun Yu²; Sagnik Dey¹; David Q. Kelly¹; Shannon D. Lewis¹; Mark A. Wistey²; Jeffrey B. Hurst¹; Sachin Joshi¹; Terry J. Mattord¹; James S. Harris²; Archie L. Holmes¹; Sanjay K. Banerjee¹; ¹University of Texas at Austin; ²Stanford University

2:50 PM

BB5, Passivation of Ge Surface Using Ceria: *Yerassimos A. Panayiotatos*¹; Andreas Sotiropoulos¹; Sotiria Galata¹; Athanasios Dimoulas¹; ¹MBE Laboratory, Institute of Materials Science, NCSR Demokritos

3:10 PM Break

3:30 PM Student

BB6, Nonlinear Optical Probing of Polarization Dynamics in Strained Ferroelectric SrTiO₃ Films: *Aravind Vasudeva Rao*¹; Sava Denev¹; Alok Sharan¹; Michael Biegalski¹; Yulan Li²; Susan Troiler-McKinstry¹; Long-Qing Chen¹; Darrell Schlom¹; Venkatraman Gopalan¹; ¹Pennsylvania State University; ²Los Alamos National Laboratory

3:50 PM Student

BB7, Epitaxial BiMnO₃ Films with Reduced Twinning and the Effect of Film Composition on Ferromagnetism: *June Hyuk Lee*¹; Yunfa Jia¹; Tassilo Heeg²; Rafael S. Freitas¹; Dmitry A. Tenne¹; Xiaoxing Xi¹; Venkatraman Gopalan¹; Peter E. Schiffer¹; Jürgen Schubert²; Darrell G. Schlom¹; ¹Pennsylvania State University; ²Institut für Schichten und Grenzflächen

4:10 PM

BB8, Single Nanoparticle Transistors: A New Thin Film Device: *Steve Campbell*¹; Yongping Ding¹; Ying Dong¹; Ameya Bapat¹; Sang Ho Song¹; Julia Daneen¹; C. Barry Carter¹; Uwe Kortshagen¹; ¹University of Minnesota

4:30 PM
BB9, Late News

4:50 PM
BB10, Late News

Session CC: Dilute Nitride Semiconductors

Thursday PM Room: Conference Room 108
June 29, 2006 Location: Pennsylvania State University

Session Chairs: Charles W. Tu, University of California; Rachel S. Goldman, University of Michigan

1:30 PM

CC1, Effect of Strain on the Nitrogen Incorporation in InGaAsN Quantum Wells Grown on GaAs and InP Substrates by Metalorganic Vapor Phase Epitaxy: *Nelson Tansu*¹; Jeng-Ya Yeh²; Luke J. Mawst²; ¹Lehigh University; ²University of Wisconsin-Madison

1:50 PM Student

CC2, TEM Analysis of GaInNAsSb Quantum Wells Grown and Annealed at Varied Temperatures: *Evan R. Pickett*¹; Seth R. Bank²; Hopil P. Bae¹; Homan B. Yuen¹; Mark A. Wistey¹; James S. Harris¹; ¹Stanford University; ²University of California at Santa Barbara

2:10 PM Student

CC3, Relative Speed and Temperature Dependence of Constituent Processes in the Annealing of GaInNAs(Sb) and Their Implications on Device Growth and Annealing: *Hopil P. Bae*¹; Seth R. Bank²; Homan B. Yuen¹; Evan R. Pickett¹; Mark A. Wistey¹; ¹Stanford University; ²University of California, Santa Barbara

2:30 PM Student

CC4, The Role of Bismuth as a Surfactant during Beryllium Doping of GaAsN Grown by Molecular Beam Epitaxy: *Ting Liu*¹; Dimitris Korakakis¹; Thomas H. Myers¹; ¹West Virginia University

2:50 PM Student

CC5, Strong Luminescence Enhancement in GaInNAsSb Quantum Wells through Variation of the Group-V Fluxes: *Seth R. Bank*¹; Hopil Bae¹; Homan B. Yuen¹; Evan R. Pickett¹; Mark A. Wistey¹; Akihiro Moto²; James S. Harris¹; ¹Stanford University; ²Innovation Core SEI, Inc.

3:10 PM Break

3:30 PM Student

CC6, Influence of Nitrogen Incorporation on Electron Transport in Selectively Doped GaAsN/AlGaAs Heterostructures: *Yu Jin*¹; Matthew Reason¹; Xiaogang Bai¹; Hugh McKay¹; Rachel Goldman¹; Cagliyan Kurdak¹; ¹University of Michigan

3:50 PM Student

CC7, Growth and Fabrication of InGaN Quantum Well Based Yellow-Red Light-Emitting Diodes: *Vladimir A. Odnoblyudov*¹; Charles Tu¹; ¹University of California, San Diego

4:10 PM

CC8, Electrical and Luminescence Properties of n- and p-Type GaPN: *Yuzo Furukawa*¹; Hiroo Yonezu¹; Akihiro Wakahara¹; Sato Atsushi¹; ¹Toyohashi University of Technology

4:30 PM

CC9, The Role of Kinetic Effects in Radiative and Non-Radiative Recombination of Optical Excitations in Dilute Nitride Heterostructures:

Theory and Experiment: *Oleg Rubel*¹; S. D. Baranovskii¹; B. Kunert¹; K. Hantke¹; W. W. Rühle¹; P. Thomas¹; K. Volz¹; W. Stolz¹; ¹Philipps University Marburg

4:50 PM Student

CC10, Bandgap Reduction and Lattice Matching in Dilute Nitride Antimonide Alloys: *Paul Jefferson*¹; Tim Veal¹; Louis Piper¹; Chris McConville¹; Brian Bennett²; Louise Buckle³; Tim Ashley³; ¹University of Warwick; ²Naval Research Laboratory; ³QinetiQ Ltd.

Session DD: P-Type Doping and Electroluminescence in ZnO

Friday AM

Room: Deans Hall I

June 30, 2006

Location: Pennsylvania State University

Session Chairs: David P. Norton, University of Florida; Yicheng Lu, Rutgers University

8:20 AM Student

DD1, Band-Edge Electroluminescence from N⁺-Implanted Bulk ZnO: *Hung-Ta Wang*¹; Fan Ren¹; Byoung S. Kang¹; Jau-Jiun Chen¹; Travis Anderson¹; Soohwan Jiang¹; Hyun-Sik Kim¹; Yuanjie Li¹; David Norton¹; Stephen Pearton¹; ¹University of Florida

8:40 AM Student

DD2, Photoluminescence and Electroluminescence Properties of ZnO Nanotips Grown on p-Type GaN: *Jian Zhong*¹; Hanhong Chen¹; Gaurav Saraf¹; Yicheng Lu¹; H. M. Ng²; C. K. Choi³; J. J. Song⁴; ¹Rutgers University; ²Bell Laboratories, Lucent Technologies; ³ZN Technology; ⁴ZN Technology, University of California, San Diego

9:00 AM

DD3, Changes in Electrical Characteristics of p-Type Zinc Oxide Thin Films Due to Light and Gas Ambient: *Bruce Claffin*¹; David C. Look¹; Gene Cantwell²; David P. Norton³; ¹Semiconductor Research Center; ²Zn Technology; ³University of Florida

9:20 AM Student

DD4, Bi-Doped ZnO Films Grown by Molecular-Beam Epitaxy: *Faxian Xiu*¹; Leelaprasanna J. Mandalapu¹; Zheng Yang¹; Jianlin Liu¹; ¹University of California, Riverside

9:40 AM Student

DD5, Phosphorus Bipolar Doping of ZnO Thin Films Fabricated by Pulsed Laser Deposition: *Arnold Allenic*¹; Wei Guo¹; Yanbin Chen¹; Guangyuan Zhao¹; Yong Che²; Zhendong Hu²; Bing Liu²; Xiaoqing Pan¹; ¹University of Michigan; ²IMRA America, Inc.

10:00 AM Break

10:20 AM

DD6, ZnO Light-Emitting Diode Fabricated by Plasma-Assisted Metal-organic Chemical Vapor Deposition: *Zhizhen Ye*¹; Weizhong Xu¹; Yujia Zeng¹; Liping Zhu¹; ¹Zhejiang University

10:40 AM

DD7, MOCVD Growth of ZnO and p-Type Doping: *Ming Pan*¹; Varatharajan Rengarajan¹; Jeff Nause¹; ¹Cermet, Inc.

11:00 AM

DD8, Characterization of Defects in Zinc Oxide Single Crystals: Balaji Raghothamachar¹; Govindhan Dhanaraj¹; Yi Chen¹; Hui Chen¹; Michael Dudley¹; Michael Callahan²; Erik Grant²; Buguo Wang³; ¹Stony Brook University; ²Air Force Research Laboratory; ³Solid State Scientific Corporation

11:20 AM

DD9, Late News

11:40 AM

DD10, Late News

Session EE: Contacts to III-Nitrides

Friday AM

Room: Deans Hall II

June 30, 2006

Location: Pennsylvania State University

Session Chairs: Huili (Grace) Xing, University of Notre Dame; Lisa Porter, Carnegie Mellon University

8:20 AM Student

EE1, Comparison of Thermally Stable TiB₂, CrB₂ and W₂B₅ Based Ohmic Contacts on n-GaN: Rohit Khanna¹; S. J. Pearton¹; F. Ren¹; I. I. Kravchenko¹; ¹University of Florida

8:40 AM Student

EE2, Reduction of Metal/GaN Barrier Height Using Nanopatterning: Ho Gyoung Kim¹; Parijat Deb¹; Timothy Sands¹; ¹Purdue University

9:00 AM Student

EE3, Investigation of a Low-Temperature Cu₃Ge Ohmic Contact to N-GaN: Michael L. Schuette¹; Wu Lu¹; ¹Ohio State University

9:20 AM

EE4, Formation of High-Quality Ag Ohmic Contacts for Flip-Chip LEDs by Using Transparent Conducting Oxide Interlayers: Hyun-Gi Hong¹; June-O Song²; J. Cho³; Y. Park³; J. S. Kwak⁴; Tae-Yeon Seong⁵; ¹Gwangju Institute of Science and Technology; ²Georgia Institute of Technology; ³SAIT; ⁴Sunchon National University; ⁵Korea University

9:40 AM

EE5, Late News

10:00 AM Break

10:20 AM Student

EE6, Analytical Transmission Electron Microscopy (TEM) Investigation of the Structural Evolution of Ti-Based Ohmic Contacts on GaN and AlGaN/GaN at Different Annealing Temperatures: Liang Wang¹; Fitihi M. Mohammed¹; Ilesanmi Adesida¹; ¹University of Illinois at Urbana-Champaign

10:40 AM Student

EE7, Low-Temperature-Annealed Mo-Based Ohmic Contacts for AlGaN/GaN Heterostructures: Anirban Basu¹; Fitihi M. Mohammed¹; Liang Wang¹; Vipin Kumar¹; Ilesanmi Adesida¹; ¹University of Illinois, Urbana-Champaign

11:00 AM Student

EE8, Si and Ge Incorporation in Ti/Al/Mo/Au for AlGaN/GaN HEMTs: Effects on Electrical and Microstructural Properties: Fitihi M. Mohammed¹; Liang Wang¹; Ilesanmi Adesida¹; ¹University of Illinois at Urbana-Champaign

11:20 AM Student

EE9, Comparison of V- and Ti-Based Ohmic Contacts to High Al-Fraction n-Al_xGa_{1-x}N: *Mary A. Horsey*¹; Katherine H. A. Bogart²; Andrew Allerman²; G. S. Cargill III³; Alexey Nikiforov⁴; ¹Pennsylvania State University; ²Sandia National Laboratories; ³Lehigh University; ⁴Boston University

11:40 AM

EE10, Late News

Session FF: Indium Nitride

Friday AM

Room: Conference Room 106

June 30, 2006

Location: Pennsylvania State University

Session Chairs: Joan M. Redwing, Pennsylvania State University;
William J. Schaff, Cornell University

8:20 AM

FF1, Origin of the N-Type Conductivity of InN – The Role of Positively Charged Nitrogen Vacancies along Threading Dislocations: *Tim Veal*¹; Louis Piper¹; Chris McConville¹; Hai Lu²; William Schaff²; ¹University of Warwick; ²Cornell University

8:40 AM

FF2, Optical Properties of the In-Polarity InN/In_{0.7}Ga_{0.3}N MQWs Grown by RF-MBE: *Song-Bek Che*¹; Takuro Shinada¹; Yoshihiro Ishitani¹; Akihiko Yoshikawa¹; ¹Chiba University

9:00 AM

FF3, In-Polar InN: Evidence of a Possible Hole Accumulation Layer: Phillip A. Anderson¹; *Steven M. Durbin*¹; Craig Swartz²; Thomas H. Myers²; S. J. Kim³; M. C. Chung³; Alexander N. Cartwright³; ¹University of Canterbury; ²West Virginia University; ³University at Buffalo, State University of New York

9:20 AM

FF4, Anisotropy of the Γ -Point Electron Effective Mass in Hexagonal InN: *Tino Hofmann*¹; T. Chavdarov²; V. Darakchieva³; H. Lu⁴; William J. Schaff²; Mathias M. Schubert¹; ¹University of Nebraska-Lincoln; ²Universität Leipzig; ³Linköping University; ⁴Cornell University

9:40 AM Student

FF5, Structural and Optical Properties of InN Layers Grown by HPCVD: *Mustafa Alevli*¹; Goksel Durkaya¹; Aruna Weerasekara¹; William Fenwick²; Vincent Woods²; Ian T. Ferguson²; Unil Perera¹; Nikolaus Dietz¹; ¹Georgia State University; ²Georgia Institute of Technology

10:00 AM Break

10:20 AM

FF6, Effect of the Growth Mode and Substrate Properties on the Biaxial Strain in InN (0001) Epilayers: *Eleftherios Iliopoulos*¹; Emmanouil Dimakis¹; Jaroslaw Domagala²; Katerina Tsagaraki¹; Alexandros Georgakilas¹; ¹Microelectronics Research Group, University of Crete, Greece, and Institute of Electronic Structure and Laser (IESL), Foundation for Research and Technology-Hellas (FORTH), Greece; ²Institute of Physics, Polish Academy of Sciences

10:40 AM

FF7, Study of Graded InGaN Buffer Layers for MOCVD Growth of Indium Nitride Thin Films: *Abhishek Jain*¹; Xiaojun Weng¹; Joan M. Redwing¹; ¹Pennsylvania State University

11:00 AM Student

FF8, Optical Properties of InN Epilayer and Self-Organized InN Quantum Dots Grown by Flow-Rate Modulated Epitaxy: *Chen-Pang Fu*¹; Wen-Cheng Ke¹; Wei-Kuo Chen¹; Chin-Hau Chia¹; Wu-Ching Chou¹; Wen-Hao Chang¹; Ming-Chih Lee¹; Ching-Shun Ku¹; ¹National Chiao Tung University

11:20 AM

FF9, Low Temperature Epitaxial Growth of InN on Substrates with Small Lattice Mismatches: *Hiroshi Fujioka*¹; Jitsuo Ohta¹; Kazuya Mitamura²; Masaharu Oshima²; ¹University of Tokyo/KAST; ²University of Tokyo

11:40 AM

FF10, Ammonothermal Growth and Characterization of Indium Nitride Crystals: *Buguo Wang*¹; M. J. Callahan²; L. Bouthillette²; K. Rakes²; M. Suscavage²; D. Bliss²; ¹Solid State Scientific; ²Air Force Research Laboratory

Session GG: Silicon and Germanium Nanowires

Friday AM

Room: Conference Room 208

June 30, 2006

Location: Pennsylvania State University

Session Chairs: Hou T. Ng, Hewlett-Packard Company;
Christopher Chidsey, Stanford University

8:20 AM Student

GG1, RF Dielectric Properties of Silicon Nanowire Networks: Wenchong Hu¹; Alexey Kovalev¹; Sarah Dilts¹; Yanfeng Wang¹; Joan M. Redwing¹; *Theresa S. Mayer*¹; ¹Pennsylvania State University

8:40 AM Student

GG2, Nanowire Bandgap Engineering through Highly Strained Si/Ge Heterostructures: *Teresa J. Clement*¹; J. L. Taraci¹; A. Batwal²; P. Peralta²; Jeff Drucker³; S. T. Picraux⁴; ¹Department of Chemical and Materials Engineering, Arizona State University; ²Department of Mechanical and Aerospace Engineering, Arizona State University; ³Department of Physics and Astronomy, Arizona State University; ⁴Center for Integrated Nanotechnology, Los Alamos National Laboratory

9:00 AM Student

GG3, Unintentional Background Doping of Vapor-Liquid-Solid Synthesized SiNWs: *Tsung-Ta Ho*¹; Yanfeng Wang¹; Kok-Keong Lew¹; Trevor Clark¹; Elizabeth Dickey¹; Joan Redwing¹; Theresa Mayer¹; ¹Pennsylvania State University

9:20 AM Student

GG4, Synthesis and X-Ray Diffraction Characterization of Hetero-epitaxially Grown Germanium Nanowires: *Irene A. Goldthorpe*¹; Joshua B. Ratchford¹; Jacob H. Woodruff¹; Christopher E.D. Chidsey¹; Paul C. McIntyre¹; ¹Stanford University

9:40 AM Student

GG5, Structural and Field-Effect Properties of Thermally-Oxidized Silicon Nanowires: *Yanfeng Wang*¹; Bangzhi Liu¹; Daniel Shir¹; Kok-Keong Lew¹; Sarah Dilts¹; Chad Eichfeld¹; Joan Redwing¹; Suzanne Mohney¹; Theresa Mayer¹; ¹Pennsylvania State University

10:00 AM Break

10:20 AM Student

GG6, Growth and Passivation of Vertically Aligned Germanium Nanowires for Three Dimensional Nanoelectronics: *Hemant Adhikari*¹; Paul C. McIntyre¹; Christopher E. D. Chidsey¹; ¹Stanford University

10:40 AM Student

GG7, Integrated Silicon Nanowire Diodes: *Justin B. Jackson*¹; Sun-Gon Jun¹; Divesh Kapoor¹; Mark S. Miller¹; ¹University of Utah

11:00 AM

GG8, Silicidation of Silicon Nanowires: *Bangzhi Liu*¹; Suzanne E. Mohney¹; Yanfeng Wang¹; Theresa S. Mayer¹; ¹Pennsylvania State University

11:20 AM Student

GG9, Self-Assembled Nickel Silicide Nanowire Contacts and Direct Electrical Measurement: *Joondong Kim*¹; Wayne A. Anderson¹; ¹University at Buffalo

11:40 AM

GG10, Late News

Session HH: Molecular Electronics: Devices, Materials and Contacts

Friday AM

Room: Conference Room 207

June 30, 2006

Location: Pennsylvania State University

Session Chairs: Mark C. Hersam, Northwestern University; David B. Janes, Purdue University

8:20 AM Student

HH1, Ordered Molecular Films on Semiconductors: Characterization of Ordered Organothiolate Monolayers on GaAs (100) and (110) for Molecular Electronic Applications: *Christine McGuinness*¹; Daniel Blasini²; Zihua Zhu¹; Sundararajan Uppili¹; Andrey Shaporenko³; Michael Zharnikov³; Detlef Smilgies⁴; Nicholas Winograd¹; David Allara¹; ¹Pennsylvania State University; ²Cornell University; ³University of Heidelberg; ⁴CHESS

8:40 AM Student

HH2, Investigating the Stability of Organic Molecules Bound to Semiconductor Surfaces with Low Temperature UHV-STM: *Nathan L. Yoder*¹; Nathan P. Guisinger¹; Mark C. Hersam¹; ¹Northwestern University

9:00 AM Student

HH3, High Resolution Inelastic Electron Tunneling Spectroscopy of Nanoscale Crossed-Wire Molecular Junctions: *Heayoung Yoon*¹; Lintao Cai¹; Marco Cabassi¹; Theresa S. Mayer¹; ¹Pennsylvania State University

9:20 AM

HH4, Single-Molecule Transistors to Characterize Bistability in Molecular Conduction: Zachary K. Keane¹; David A. Corley¹; Jacob W. Ciszek¹; James M. Tour¹; *Douglas Natelson*¹; ¹Rice University

9:40 AM Student

HH5, Criteria for Statistical Determination of Working Devices of Microscale via-Hole Molecular Structures: *Tae-Wook Kim*¹; Gunuk Wang¹; Takhee Lee¹; ¹Gwangju Institute of Science and Technology

10:00 AM Break

10:20 AM

HH6, Fundamental Studies of Vapor Deposited Metal Contacts for Molecular Electronics Devices: *Thomas A. Daniel*¹; David L. Allara¹; Masato Maitani¹; Tim Tighe¹; ¹Pennsylvania State University

10:40 AM Student

HH7, Electrical and Structural Characterization of Evaporated Contacts in Au/Molecule/GaAs Devices: *Patrick D. Carpenter*¹; Saurabh Lodha¹; David B. Janes¹; Amy V. Walker²; ¹Purdue University; ²Washington University in St. Louis

11:00 AM Student

HH8, Molecule-Electrode Contact Effect on the Conductance of Single Alkanedithiols: *Xiulan Li*¹; Joshua Hihath¹; ¹Arizona State University

11:20 AM Student

HH9, Scalable Molecular Electrodes at the Patterned Edge of a Metal/Insulator/Metal Junction: *Pawan Tyagi*¹; Dong Feng¹; Steve Holmes¹; Bruce J. Hinds¹; ¹University of Kentucky

11:40 AM Student

HH10, From Quantum Chemistry to Molecular Electronic Circuits: *Yuhui Lu*¹; Craig Lent¹; ¹University of Notre Dame

Session II: Trapping and Charge Transport in Organic Transistors

Friday AM

Room: Conference Room 206

June 30, 2006

Location: Pennsylvania State University

Session Chairs: Thomas Jackson, Pennsylvania State University;
David J. Gundlach, National Institute of Standards and Technology

8:20 AM Invited

II1, Trapping of Majority and Minority Carriers at the Insulator-Polymer Semiconductor Interface: *David M. Taylor*¹; Oscar Fernandez¹; Janet Lancaster¹; ¹University of Wales, Bangor

9:00 AM Student

II2, Trap Energy Determination by Analysis of Isothermal Gated Space-Charge-Limited Current in Organic Thin-Film Transistors: *Richard D. Yang*¹; Xiaotian Zhou¹; Edward Yu¹; Andrew Kummel¹; ¹University of California, San Diego

9:20 AM Student

II3, Measurement of Drift Velocity and Mobility of Carriers in a Polymer Thin-Film Transistor: *Debarshi Basu*¹; Liang Wang¹; Lawrence Dunn¹; Ananth Dodabalapur¹; Martin Heeney²; Iain McCulloch²; ¹University of Texas at Austin; ²Merck Chemicals

9:40 AM

II4, Influence of Charged Dielectrics and Adsorbed Dipoles on Organic Semiconductors in Transistor Architectures: *Howard E. Katz*¹; Cheng Huang¹; Kevin See¹; Alan Becknell²; ¹Johns Hopkins University; ²Applied Physics Laboratory

10:00 AM Break

10:20 AM Student

II5, Charge Transport as a Function of Gate Voltage and Temperature in N,N'-bis(n-octyl)-Dicyanoperylene-3,4:9,10-bis(Dicarboximide) [PDI-8CN2]: *Yeon Taek Jeong*¹; Byungwook Yoo¹; Brooks Jones²; Antonio Facchetti²; Tobin Marks²; Ananth Dodabalapur¹; ¹University of Texas at Austin; ²Northwestern University

10:40 AM

II6, Using High-Sensitivity Electric Force Microscopy to Probe Charge Trapping in Pentacene Thin-Film Transistors: *Michael J. Jaquith*¹; Showkat M. Yazdani¹; Tse Nga Ng²; John A. Marohn¹; ¹Cornell University;

²Palo Alto Research Center

11:00 AM Student

II7, Charge Transport at Very High Carrier Densities in Organic Semiconductor Thin Films and Single Crystals: *Matthew J. Panzer*¹; C. Daniel Frisbie¹; ¹University of Minnesota

11:20 AM

II8, Building Blocks for Single-Component Organic Electronics: Electrostatic Modulation and Majority Carrier Sign Inversion of Organic Semiconductors via Polarized Gates: *Cheng Huang*¹; Howard E. Katz¹; James E. West¹; ¹Johns Hopkins University

11:40 AM

II9, High-Mobility Charge Transport in Laminated Rubrene Crystal/Polymer Field-Effect Transistors: *Jun Takeya*¹; Koichi Yamada²; Kazuhito Tsukagoshi³; Yoshinobu Aoyagi³; Yasuhiro Nakazawa¹; Yoshihiro Iwasa⁴; ¹Osaka University; ²CRIEPI; ³RIKEN; ⁴Tohoku University

Session JJ: Spintronic Materials

Friday AM

Room: Conference Room 108

June 30, 2006

Location: Pennsylvania State University

Session Chairs: Chris J. Palmstrom, University of Minnesota; Nitin Samarth, Pennsylvania State University

8:20 AM

JJ1, Magnetoresistance and Insulator-Metal Transition of EuO_{1-x} Thin Films Grown on (110) YAlO_3 and (001) Si Substrates: *Andreas Schmehl*¹; Venu Vaithyanathan¹; Raghava Panguluri²; Boris Nadgorny²; Marco Liberati³; Yves Idzerda³; Alexander Weber⁴; Jochen Mannhart⁴; Darrell G. Schlom¹; ¹Pennsylvania State University; ²Wayne State University; ³Montana State University; ⁴University of Augsburg

8:40 AM Student

JJ2, High Field Magnetoresistance and Hall Effect Studies of Nonmagnetic Al- and Cu-Doped (Zn,Mn)O Dilute Magnetic Semiconductors: *Theodore W. Kehl*¹; C. Vera¹; S. Manchiraju¹; D. Horst¹; K. Manivannan¹; J. Griffiths²; P. Kahol¹; K. Ghosh¹; S. R. Mishra²; ¹Missouri State University; ²University of Memphis

9:00 AM

JJ3, Conduction-Band Electron Effective Mass in $\text{Zn}_{0.87}\text{Mn}_{0.13}\text{Se}$ Measured by Terahertz and Far-Infrared Magneto-optic Ellipsometry: *Tino Hofmann*¹; K. C. Agarwal²; B. Daniel²; C. Klingshirn²; M. Hetterich²; C. M. Herzinger³; M. M. Schubert¹; ¹University of Nebraska-Lincoln; ²Universität Karlsruhe; ³J.A. Woollam Company, Inc.

9:20 AM Student

JJ4, Ferromagnetism in Fe-Implanted ZnO Films and Nanotips: *Pan Wu*¹; Gaurav Saraf¹; Yicheng Lu¹; David Hill¹; Dario Arena²; Robert Bartynski¹; Leszek Wielunski¹; Jeremy Raley³; Yung Kee Yeoo³; ¹Rutgers University; ²Brookhaven National Laboratory; ³Air Force Institute of Technology

9:40 AM Student

JJ5, Dilute Magnetic MnGe Semiconductor Using Ion Implantation of Mn into Nano-Patterned Ge: *Jingjing Chen*¹; Kos Galatsis¹; Kang Wang¹; Jiayu Wang²; Thomas P. Russell²; ¹University of California, Los Angeles; ²University of Massachusetts

10:00 AM Break

10:20 AM

JJ6, Direct Imaging of Photo-Induced Changes in Magnetization Orientation in (Ga,Mn)As by a Scanning Magneto-Optical Microscope: *Tsuyoshi Kondo*¹; Kenta Nomura¹; Gaku Koizumi¹; Hiro MuneKata¹; ¹Tokyo Institute of Technology

10:40 AM Student

JJ7, Electroluminescence Studies of (Ga,Mn)As-Based p-i-n Structures: *Zhiguo Ge*¹; Raja Chakarvorty¹; Shaoping Shen¹; Weng-Lee Lim¹; Xinyu Liu¹; Jacek Furdyna¹; Malgorzata Dobrowolska¹; ¹University of Notre Dame

11:00 AM Student

JJ8, Ferromagnetic Co₂MnGe Contacts for GaAs: Growth, Characterization, and Interface Stability: *J. L. Hilton*¹; B. D. Schultz¹; X. Lou²; P. A. Crowell²; C. J. Palmstrom¹; ¹Department of Chemical Engineering and Materials Science, University of Minnesota; ²School of Physics and Astronomy, University of Minnesota

11:20 AM

JJ9, Magnetic Characterization of Fe/Tb Superlattice Grown on InAs as a Vertically Magnetized Spin Injector: *Kanji Yoh*¹; Robert Peters²; Marhoun Ferhat³; Saori Kashiwada¹; Werner Keune²; ¹Hokkaido University; ²University of Duisburg-Essen; ³JST

11:40 AM Student

JJ10, Thickness Determination of Ultra-Thin Oxide Films and the Application in Magnetic Tunnel Junctions: *Jianhua Joshua Yang*¹; Chengxiang Ji¹; Y. Austin Chang¹; Ying Yang¹; Feng X. Liu²; Bharat B. Pant²; Allan E. Schultz²; ¹University of Wisconsin-Madison; ²Seagate Technologies

Session KK: GaN Characterization

Friday PM

Room: Deans Hall II

June 30, 2006

Location: Pennsylvania State University

Session Chairs: Randall M. Feenstra, Carnegie Mellon University; Michael Wraback, U.S. Army Research Laboratory

1:30 PM

KK1, A Dynamic Micro-Analysis of Temperature Distribution and Electric Potential Distribution of AlGaN/GaN HFETs Using Micro-Raman Spectroscopy and Kelvin-Force Microscopy: *Akira Suzuki*¹; Shin-ichi Kamiya²; Masayuki Iwami²; Yuichi Hiroyama²; Tadayoshi Tsuchiya²; Tomoyuki Yamada²; Junjiroh Kikawa²; Ken-Ichi Kosaka¹; Tsutomu Araki¹; Yasushi Nanishi¹; ¹Ritsumeikan University; ²Advanced HF Device R&D Center, R&D Association for Future Electron Devices

1:50 PM Student

KK2, Selective Quantification of AlGaN-Related Deep Levels in AlGaN/GaN Heterostructures Using Capacitance-Mode Deep Level Optical Spectroscopy: *Andrew Armstrong*¹; Christiane Plobenz²; Siddharth Rajan²; James S. Speck²; Umesh K. Mishra²; Steven A. Ringel¹; ¹Ohio State University; ²University of California, Santa Barbara

2:10 PM

KK3, Anisotropic Strain in GaN Films Grown on *a*-Plane and *r*-Plane Sapphire: Effect on GaN Phonons: *V. Darakchieva*¹; T. Paskova²; M. Schubert³; P. P. Paskov¹; H. Arwin¹; B. Monemar¹; M. Heuken⁴; S. Figge²; D. Hommel²; B. A. Haskell⁵; P. T. Fini⁵; S. Nakamura⁵; ¹Linkoping University; ²University of Bremen; ³University of Nebraska; ⁴Aixtron AG; ⁵University of California, Santa Barbara

2:30 PM Student

KK4, Phase Separation and Defects in Quaternary $\text{In}_x\text{Al}_y\text{Ga}_{1-x-y}\text{N}$ Layers: *Fanyu Meng*¹; Rao Manu¹; Nathan Newman¹; Subhash Mahajan¹; ¹Department of Chemical and Materials Engineering and Center for Solid State Electronics Research, Arizona State University

2:50 PM

KK5, Consequences of Polarity and Related Defects on the Electrical Properties of GaN Grown by MOVPE: *Ramon Collazo*¹; Aleks Aleksov¹; Seiji Mita¹; Raoul Schlessler¹; Zlatko Sitar¹; ¹North Carolina State University

3:10 PM Break

3:30 PM Student

KK6, Defect Reduction in GaN through Formation of ‘Dislocation Clusters’ at the Nanoheteroepitaxial Interface: *Mohammad Ferdous*¹; Xinyu Sun¹; Xin Wang¹; Michael Fairchild¹; Steve Hersee¹; ¹University of New Mexico

3:50 PM Student

KK7, Influence of Arsenic Isovalent Co-Doping on the Electronic Properties of N-Type and P-Type GaN Grown by Metal-Organic Chemical Vapor Deposition: *David Gray*¹; Michael Willemann¹; Kai Zhang¹; Ali Hajjiah¹; Kevin Chern¹; Alex Aning¹; Louis J. Guido¹; ¹Virginia Tech

4:10 PM

KK8, Strong Light-Matter Coupling a Room Temperature in GaN Microcavities: *Ian R. Sellers*¹; Fabrice Semond¹; Mathieu Leroux¹; Jean Massies¹; Pierre Disseix²; Joel Leymarie²; ¹Centre de Recherche sur l’Hétéro-Epitaxie et ses Applications; ²LASMEA-Université Baisle Pascal

4:30 PM Student

KK9, Microstructural Investigation of AlN Re-Growth by MOCVD: *Xianglin Li*¹; Ramon Collazo¹; Rafael Dalmau¹; Seiji Mita¹; Zlatko Sitar¹; ¹North Carolina State University

4:50 PM

KK10, Late News

Session LL: Compound Semiconductor Nanowires

Friday PM

Room: Conference Room 208

June 30, 2006

Location: Pennsylvania State University

Session Chair: Timothy D. Sands, Purdue University

1:30 PM

LL1, InAs Nanowire Transistors Using Solution-Grown Nanowires with Acceptor Doping: *Qingling Hang*¹; David Janes¹; Fudong Wang²; William Buhro²; ¹Purdue University; ²Washington University in St. Louis

1:50 PM

LL2, Photocurrent Spectroscopy of Solution-Synthesized Nanowire-Based Photodetectors: *Huili (Grace) Xing*¹; Xiangyang Li²; Amol K. Singh¹; Debdeep Jena¹; Masaru K. Kuno¹; ¹University of Notre Dame; ²Shanghai Institute of Technical Physics, Chinese Academy of Science

2:10 PM Student

LL3, Growth Mechanism and Optimization of InAs Nanowires Synthesized by OMVPE: *Shadi A. Dayeh*¹; David Aplin¹; Edward T. Yu¹; Deli Wang¹; Paul K. L. Yu¹; ¹University of California, San Diego

2:30 PM

LL4, III-V Nanostructures Formed from GaP Nanowires on Si(111) Substrates: *Kouta Tateno*¹; Hiroki Hibino¹; Haruki Sanada¹; Hideki Gotoh¹; Hidetoshi Nakano¹; ¹NTT Basic Research Laboratories

2:50 PM

LL5, The Fabrication of Extreme Aspect Ratio Semiconductor and Metal Wires within Photonic Crystal Fibers: *Neil Baril*¹; Don-Jin Won¹; Thomas Scheidemantel¹; Adrian Amezcua-Correa²; Chris Finlayson²; John Hayes²; Pier Sazio²; Venkatraman Gopalan¹; John Badding¹; ¹Pennsylvania State University; ²University of Southampton

3:10 PM Break

3:30 PM

LL6, In Situ Electrical Annealing of Bio-Templated Nanowires: *Yan Gao*¹; Gary Braun¹; Chung-Yi Chiang²; Jing C. Zhou³; Norbert O. Reich¹; Angela Belcher²; Bruce Dunn³; Evelyn Hu¹; ¹University of California, Santa Barbara; ²Massachusetts Institute of Technology; ³University of California, Los Angeles

3:50 PM Student

LL7, Contacts to Gold Nanowires in Porous Anodic Alumina Templates: *Kalapi Biswas*¹; Yexian Qin¹; Manuel Da'Silva¹; Ron Reifenger¹; Tim Sands¹; ¹Purdue University

4:10 PM

LL8, Three-Dimensional Nanoscale Composition Mapping of Semiconductor Nanowires: *Lincoln J. Lauhon*¹; Daniel E. Perea¹; Steven J. May¹; Jessica L. Lensch¹; Jonathan E. Allen¹; Bruce W. Wessels¹; David N. Seidman¹; ¹Northwestern University

4:30 PM Student

LL9, Photoluminescent Properties of ZnO/Mg_{0.2}Zn_{0.8}O Coaxial Nanorod Quantum Structures: *Jinkyung Yoo*¹; Gyu-Chul Yi¹; Bonghwan Chon¹; Taiha Joo¹; Takahashi Yatsui²; Motoichi Ohtsu³; ¹POSTECH; ²Japan Science and Technology Agency; ³University of Tokyo

4:50 PM Student

LL10, Transport Properties of Solution Grown Thin Film Nanowire Solids: *Amol K. Singh*¹; Xiangyan Li²; Vladimir Protasenko¹; Masaru Ken Kuno¹; Huili Grace Xing¹; Debdeep Jena¹; ¹University of Notre Dame; ²Shanghai Institute of Technical Physics

Session MM: Chemical and Biological Sensors II

Friday PM Room: Conference Room 207
June 30, 2006 Location: Pennsylvania State University

Session Chairs: Debdeep Jena, University of Notre Dame; Alec Talin, Sandia National Laboratories

1:30 PM Student

MM1, Chemical Sensor Applications Using Functionalized Conducting Polymer Nanojunction Array: *Alvaro Diaz Aguilar*¹; Erica Silvia Forzani¹; Xiulan Li¹; Larry Nagahara²; Islamshah Amlani²; Raymond Tsui²; Nongjian Tao¹; ¹Arizona State University; ²Motorola Laboratories

1:50 PM

MM2, Modification of Nanoparticle-Organic Composite Electronic Materials for Improved Chemical Sensors: *Stephen W. Howell*¹; Shawn Dirk¹; David Wheeler¹; Robert J. Simonson¹; ¹Sandia National Laboratories

2:10 PM

MM3, Conductance Sensor Based on Polyion Stabilized and Thiol Functionalized Double Stranded DNA Molecules: *Ajit K. Mahapatro*¹; Kyung J. Jeong¹; Sugata Bhattacharya¹; Gil U. Lee¹; David B. Janes¹; ¹Purdue University

2:30 PM Student

MM4, AFM Study of Current Transport through Porphyrin Based Molecules: *Raghu Ramachandran*¹; Kim Lewis¹; Sathish Thiruvengadam¹; Roy Siow¹; Theda Daniels-Race¹; ¹Louisiana State University

2:50 PM Student

MM5, Surface Plasmon Resonance: Sensing Chips and Applications: *Kyle Foley*¹; Erica Forzani¹; Nguyen Ly¹; Paul Westerhoff¹; Nongjian Tao¹; ¹Arizona State University

3:10 PM Break

3:30 PM Student

MM6, The Functionalization of GaN and AlGaN Surfaces with Hemin for Nitric Oxide Detection: *Michael A. Garcia*¹; Scott D. Wolter¹; James B. Sund¹; Tong-Ho Kim¹; Joseph Bonaventura¹; April Brown¹; ¹Duke University

3:50 PM

MM7, BioFETs Based on GaN/AlGaN Devices: *Kendra McCoy*¹; Stephen Pearton²; Lloyd Whitman¹; ¹Naval Research Laboratory; ²University of Florida

4:10 PM

MM8, Sensing Characteristics and Mechanism of Liquid-Phase and Gas-Phase Sensors Using AlGaN/GaN Heterostructure: Takuya Kokawa¹; Kazuo Matsuo¹; Takeshi Kimura¹; *Hideki Hasegawa*¹; Tamotsu Hashizume¹; ¹Hokkaido University

4:30 PM Student

MM9, Scalable Dope-Coded Biosensing Particles for Protein Detection: *Nguyen H. Ly*¹; Nongjian Tao¹; ¹Arizona State University

4:50 PM

MM10, Electric Field Dependence of Photoluminescence of Silica Coated CdSe/CdS Quantum Dots: *Yang Xu*¹; Kathleen Meehan¹; ¹Virginia Polytechnic Institute and State University

Questions?

Registration

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